



Lecture #2— Nuts and Bolts of Oxide MBE: Growth Conditions, Sources, and Crucibles

Darrell G. Schlom

Nuts and Bolts of Oxide MBE

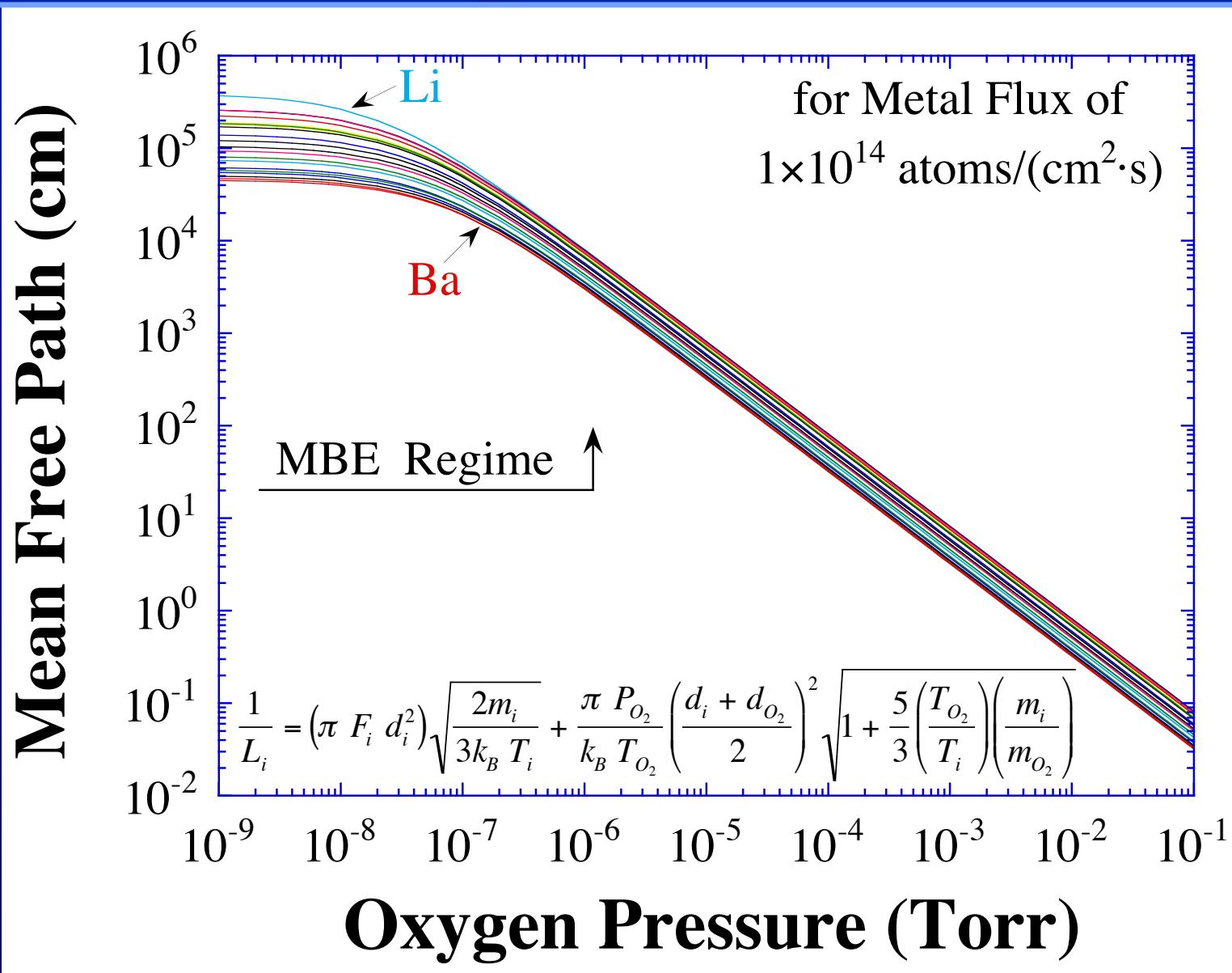
How to grow your favorite oxide by MBE?

- Lecture #2—*Growth Conditions, Sources, and Crucibles*
- Lecture #3—*Composition Control and Calibration*
- Lecture #4—*Epitaxy, Substrates, and Crystal Growth*

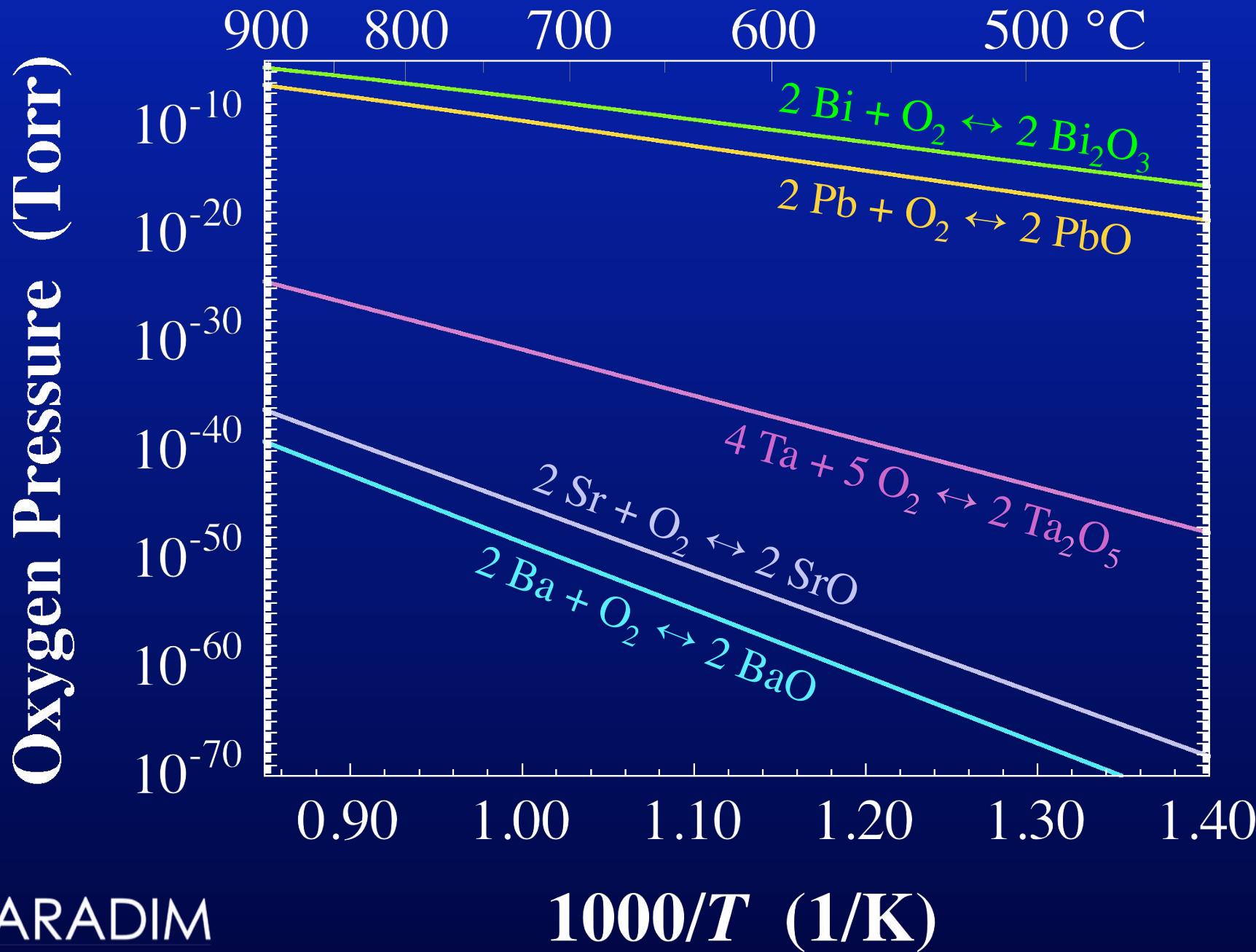
Nuts and Bolts of Oxide MBE

- Mean Free Path (maximum P_{O_2})
- Minimum P_{O_2} , need for P_{O_3}
- Optimal T_{sub}
- MBE System
- MBE Sources
- Crucibles

Maximum O₂ Pressure for MBE

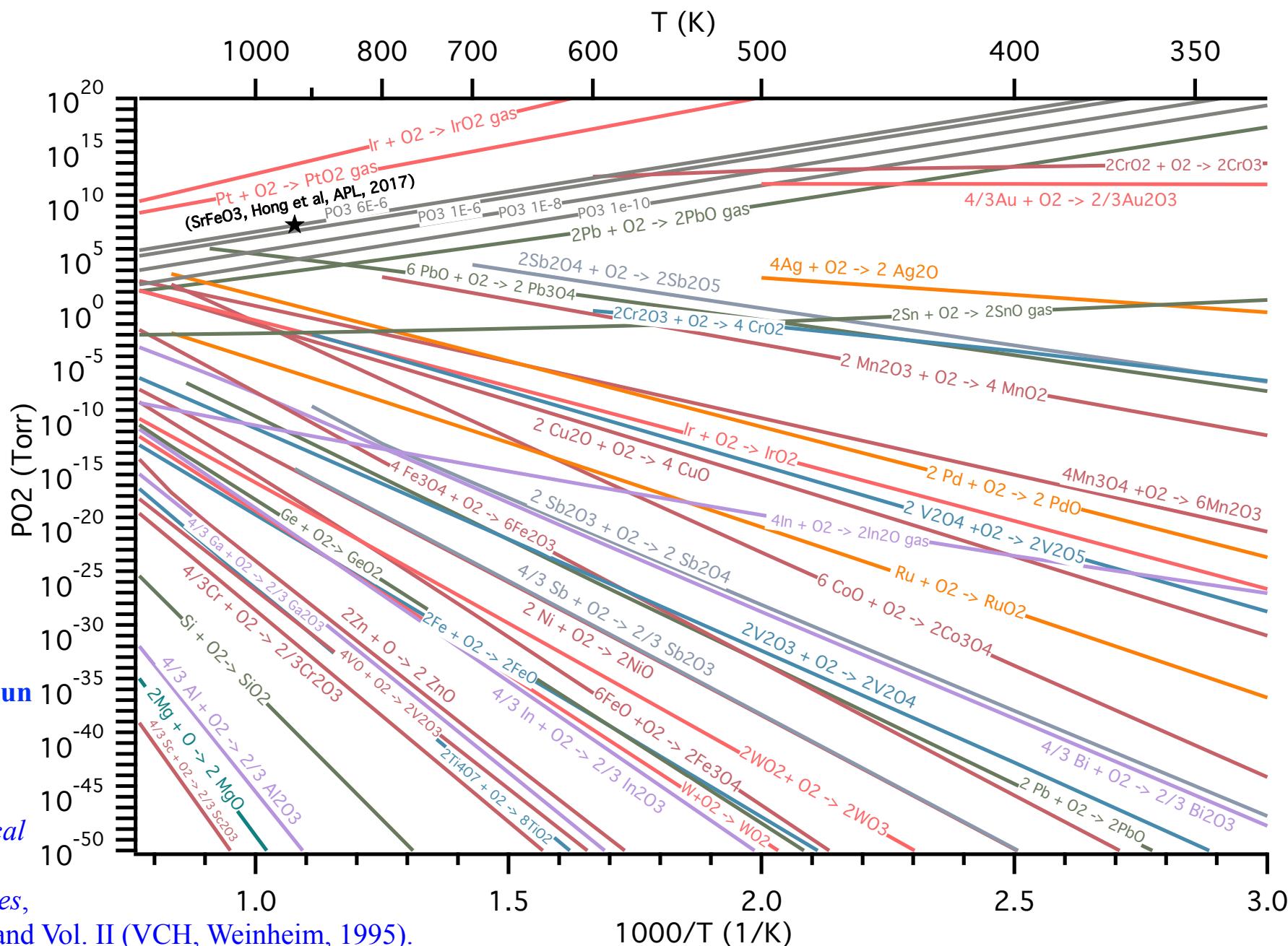


O_2 Needed to Oxidize Constituents



data from I. Barin, *Thermochemical Data of Pure Substances*,
3rd Ed., Vol. II (VCH, Weinheim, 1995).

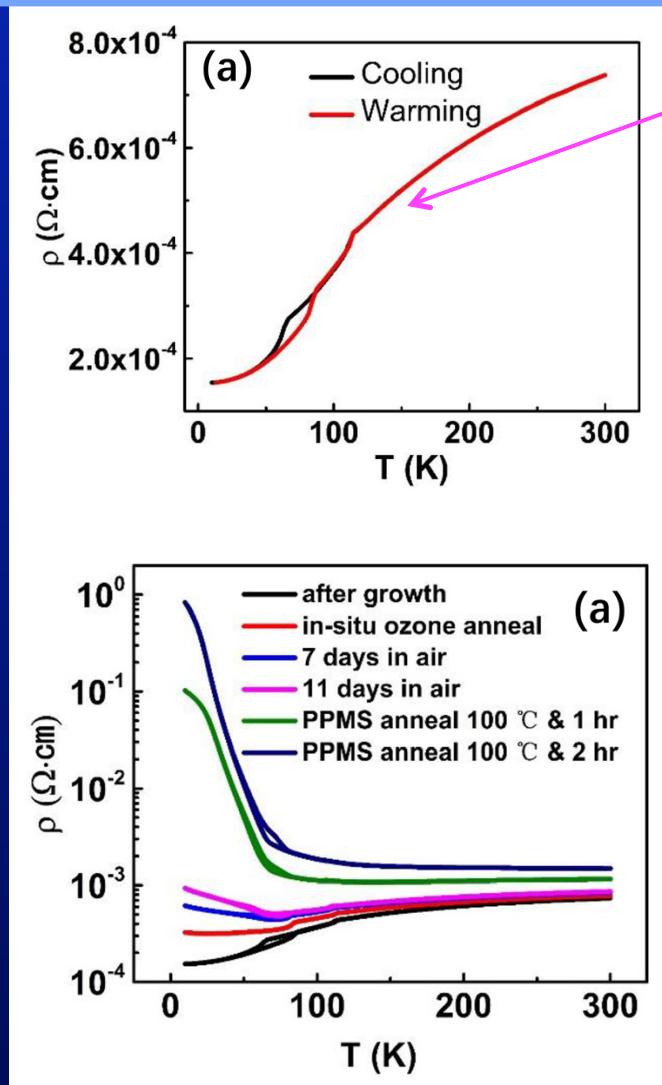
O₂ Needed to Oxidize Constituents



plot by Jake Sun

data from
I. Barin,
*Thermochemical
Data of
Pure Substances*,
3rd Ed., Vol. I and Vol. II (VCH, Weinheim, 1995).

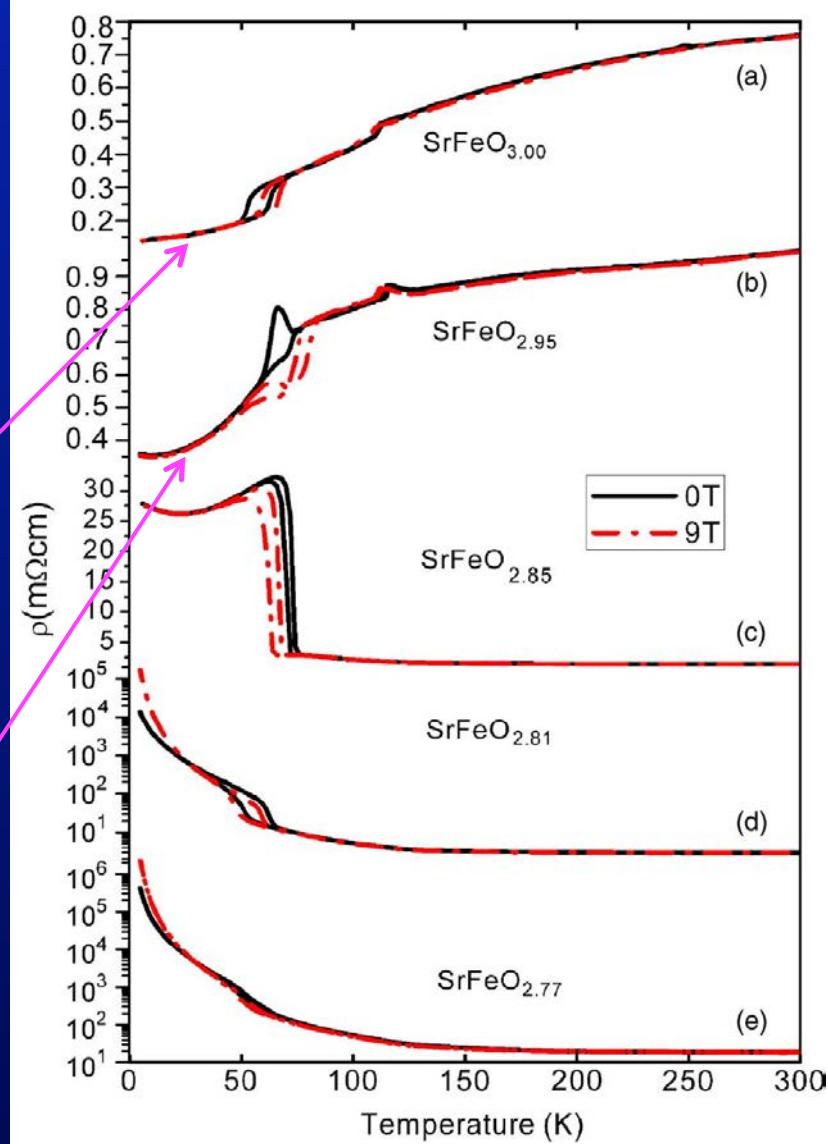
SrFeO_{3-x} Example with Ozone



As-grown (by MBE) $\sim \text{SrFeO}_3$ film. Grown and cooled in 6×10^{-6} Torr of distilled ozone

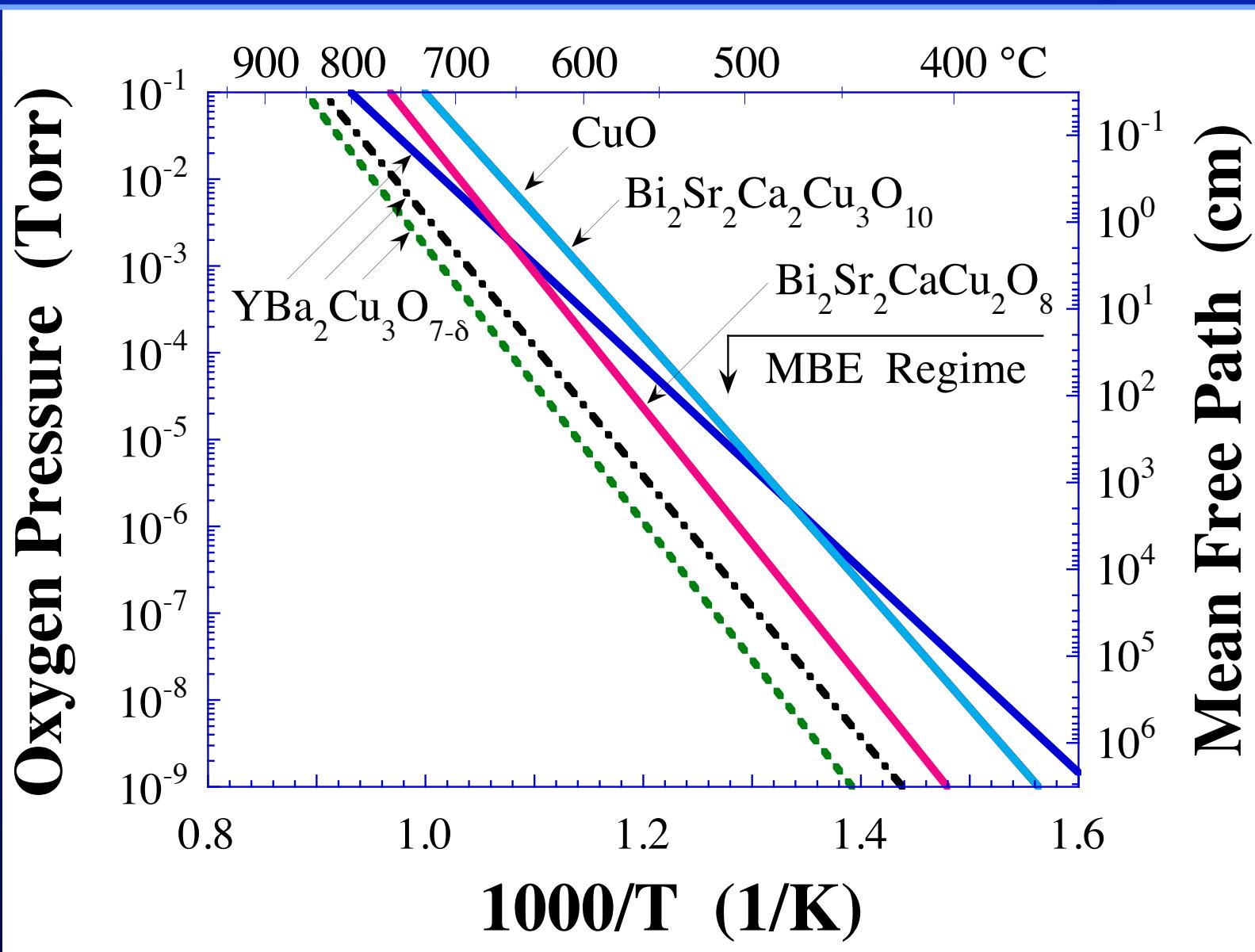
$\text{SrFeO}_{3.00}$ single crystal annealed 5000 atm O_2 at 400 °C

$\text{SrFeO}_{2.95}$ single crystal annealed 750 atm O_2 at 400 °C

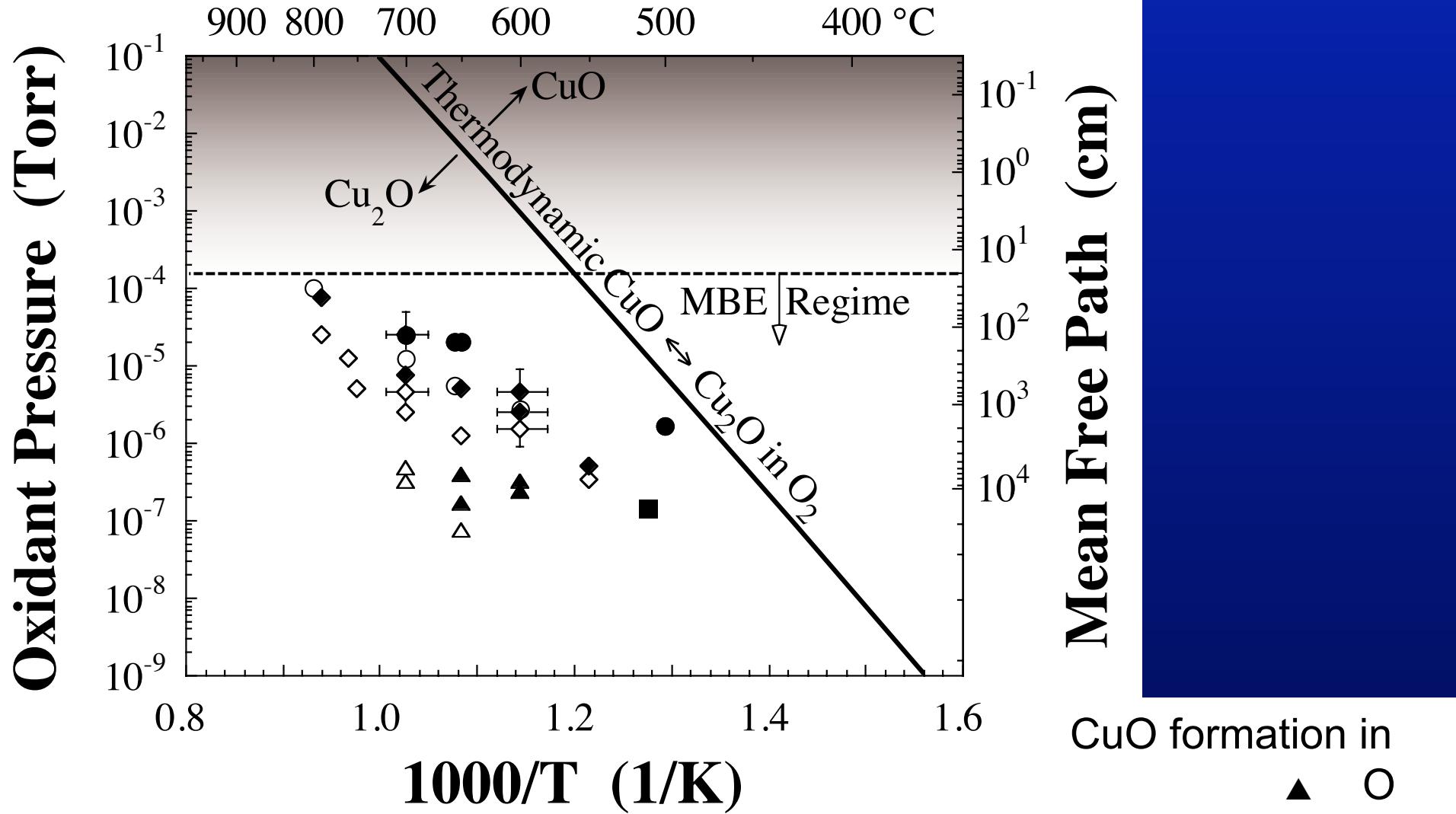


D. Hong, C. Liu, J. Pearson, and A. Bhattacharya,
Applied Physics Letters **111** (2017) 232408.

O_2 Needed to Oxidize Cuprates



Superior Oxidants to O₂



D.G. Schlom and J.S. Harris, Jr., in *Molecular Beam Epitaxy: Applications to Key Materials*, edited by R.F.C. Farrow (Noyes, Park Ridge, 1995), pp. 505-622.

CuO formation in

- ▲ O
- O⁺
- NO₂
- ◆ O₃

O₃ Activity by Thermodynamics

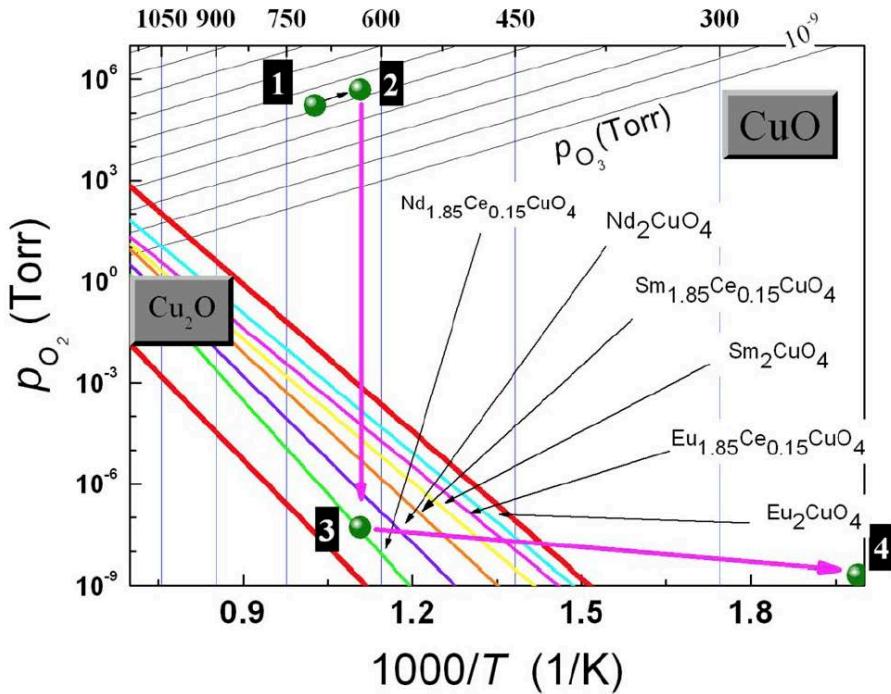
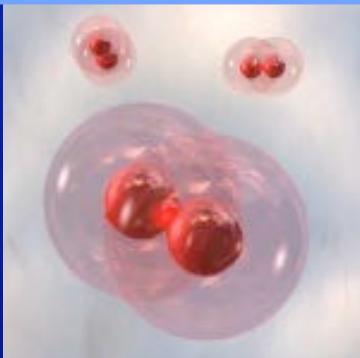


FIG. 1. (Color online) Typical thermodynamic phase stability diagram for electron-doped cuprates. Stability lines for CuO and Cu₂O have been calculated using the commercially available program MALT®. Additionally, the equilibria oxidizing potential lines for ozone and oxygen are calculated. The numbered points describe a typical growth of the thin film. The border lines for the different copper valencies are thick red colored. Between them, all experimentally established stability lines for the T'-structure compounds are lying. Points 1 and 2 represent the growth followed by annealing in vacuum (point 3) and afterwards cooled down to point 4.

$$O_2 \xrightleftharpoons[\Delta G^\circ]{2}{3} O_3$$
$$P_{O_2} = P_{O_3}^{2/3} e^{\left(\frac{\Delta G^\circ}{RT_{sub}}\right)}$$

Activity of O₃ is ~10¹² higher than O₂ at typical T_{sub}

Oxygen vs. Ozone



Oxygen:

- Easy to use – directly from the cylinder
- Depending on material, films are oxygen-deficient



Ozone from ozone generator:

- Around 15 wt% O_3 in O_2
- As O_3 easily decomposes, one O_3 is similar to one O radical
- Higher wt% not achievable, saturation of O_3 concentration



Distilled ozone:

- Can provide 80-100 wt% pure O_3
- Better film oxidation, wider process window
- But: Gas is explosive above ~10 Torr (absolute), liquid is explosive and shock-sensitive

Vapor Pressure Oxygen vs. Ozone

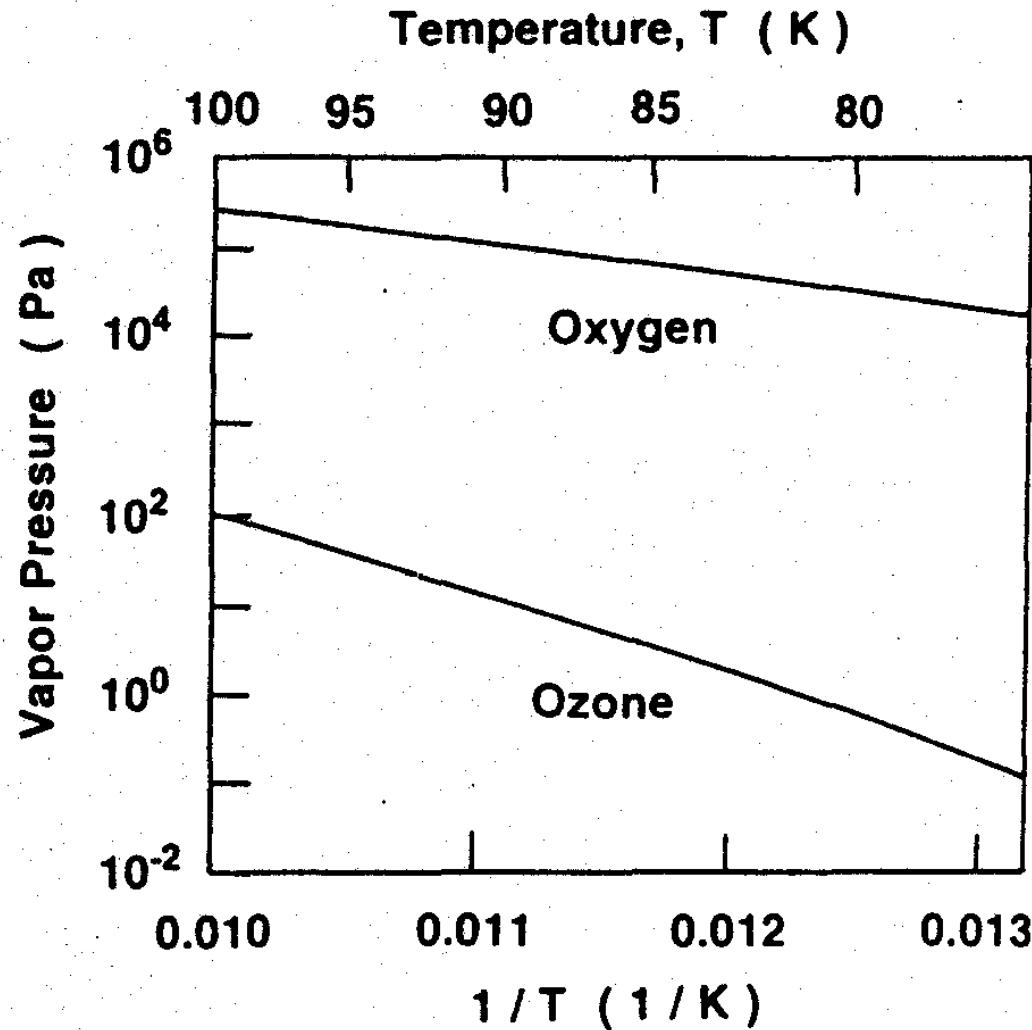


FIG. 4. Vapor pressure of ozone and oxygen as a function of temperature.

S. Hosokawa, and S. Ichimura, "Ozone Jet Generator
as an Oxidizing Reagent Source for Preparation of Superconducting Oxide Thin Film,"
Review of Scientific Instruments **62** (1991) 1614-1619.

Ozone Safety Concerns

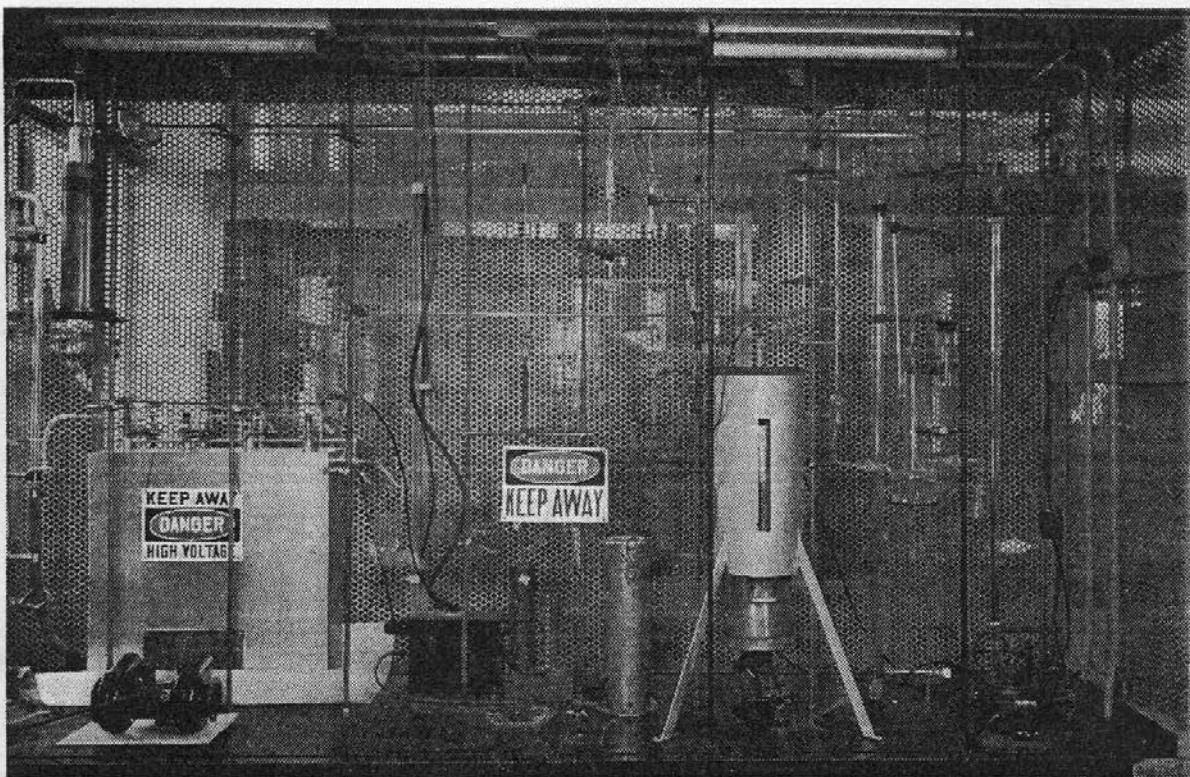


Figure 4. Ozone system

A.C. Jenkins

“Laboratory Techniques for Handling High-Concentration Liquid Ozone,” in:

Ozone Chemistry and Technology

Vol. 21 of Advances in Chemistry Series

(American Chemical Society, Washington, D.C., 1959) pp. 13-21.

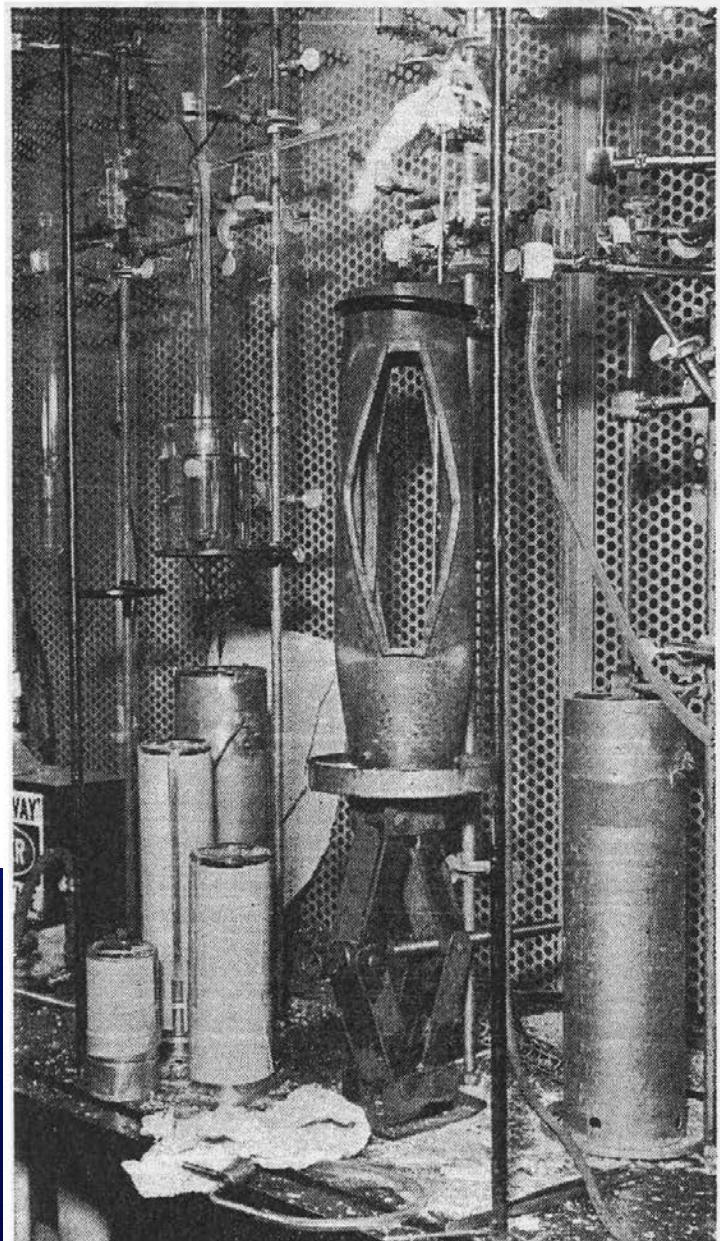


Figure 5. Apparatus after explosion

Ozone Safety Concerns

OZONE FOR ROCKETS

Concentrated liquid ozone has been proposed as a rocket fuel by Prof. Clark E. Thorp of the Illinois Institute of Technology, who recently disclosed advances made at the Institute by which ozone can be handled with safety. Ozone is a form of oxygen with three atoms to the molecule instead of two as in ordinary life-supporting oxygen. By demonstrating that it can be safely manufactured, Professor Thorp stated, the door has been opened for tonnage production. During World War II, German scientists worked overtime on an ozone-propelled rocket designed to bombard New York City from European launching platforms. But they were unable to discover the secret of handling ozone without spontaneous detonation.

“Ozone for Rockets,”
Ordnance: The Journal of the Army Ordnance Association 36 [187] (July-August 1951) pp. 108-110.



Ozone Distillation (U. Minnesota)

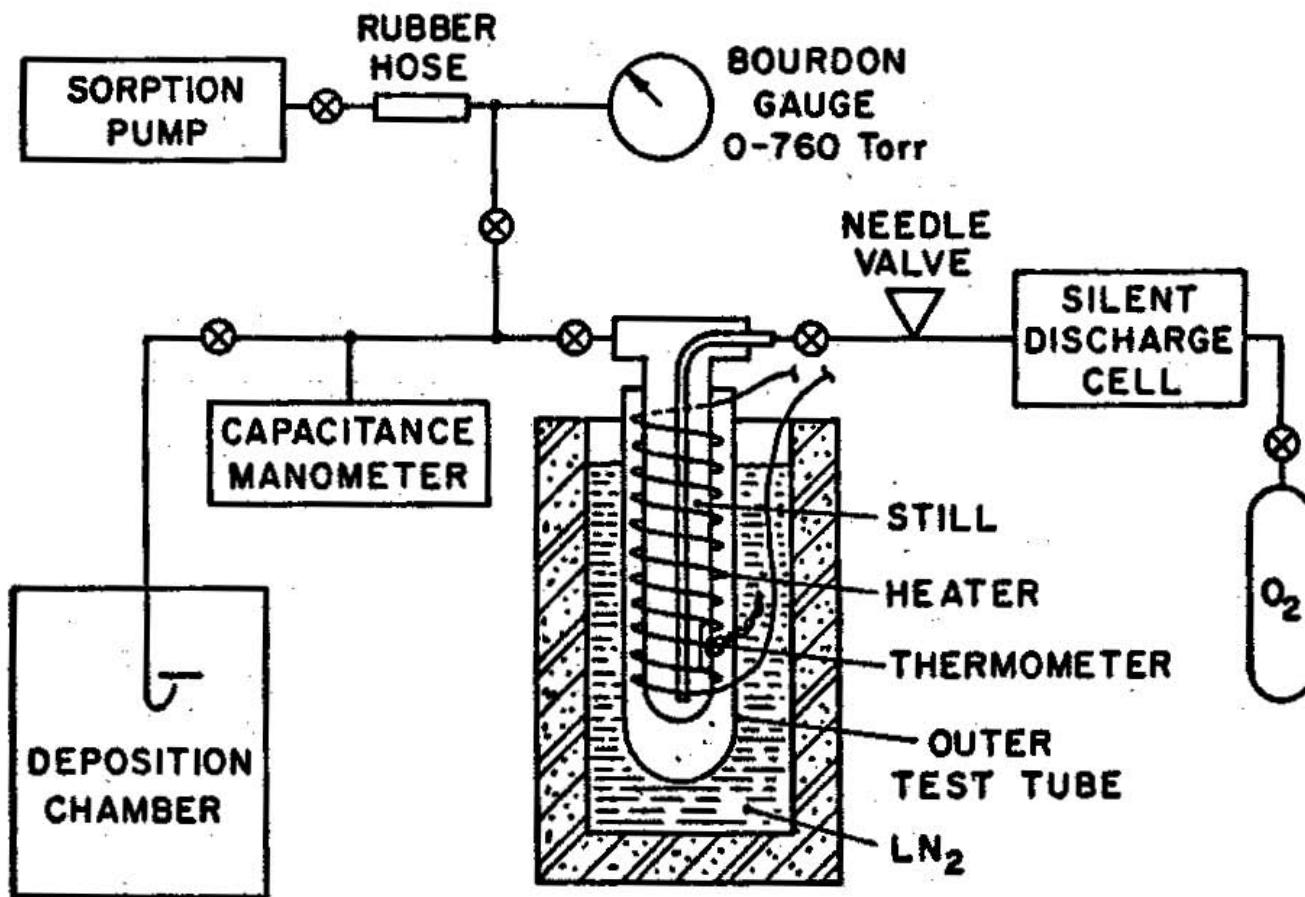


FIG. 1. Ozone-production and storage apparatus. During production of ozone, the still heater is off and the outer test tube surrounding the still is filled with liquid nitrogen.

Ozone in Silica Gel (Union Carbide)

Separation of Ozone from Oxygen by a Sorption Process

G. A. COOK, A. D. KIFFER, C. V. KLUMPP, A. H. MALIK, and L. A. SPENCE

Research and Development Laboratory, Linde Co., A Division of Union Carbide Corp., Tonawanda, N. Y.

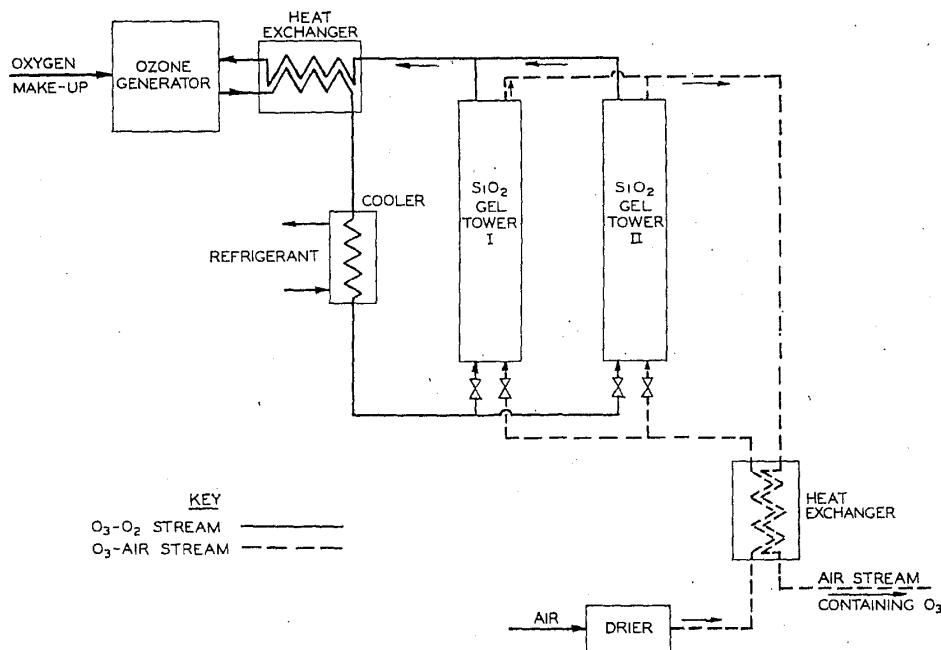


Figure 7. Simplified flow diagram for two-stage transfer process

Ozone is separated from oxygen by adsorption on refrigerated silica gel, followed by desorption, either in pure form at reduced pressure, or diluted by air, nitrogen, argon, or other gas not strongly adsorbed on silica gel. This is a practical method, free from hazard when correctly performed.

G.A. Cook, A.D. Kiffer, , C.V. Klumpp, A.H. Malik,
and L.A. Spence,

"Separation of Ozone from Oxygen
by a Sorption Process," in:
Ozone Chemistry and Technology,

Vol. 21 of Advances in Chemistry Series, (American
Chemical Society, Washington, D.C., 1959) pp. 44-52.

Ozone in Silica Gel (Union Carbide)

Safety Tests

An electric spark was passed between two tungsten electrodes within the gel bed. No explosions took place at -105° C . with loadings as high as 21 grams of ozone per 100 grams of gel.

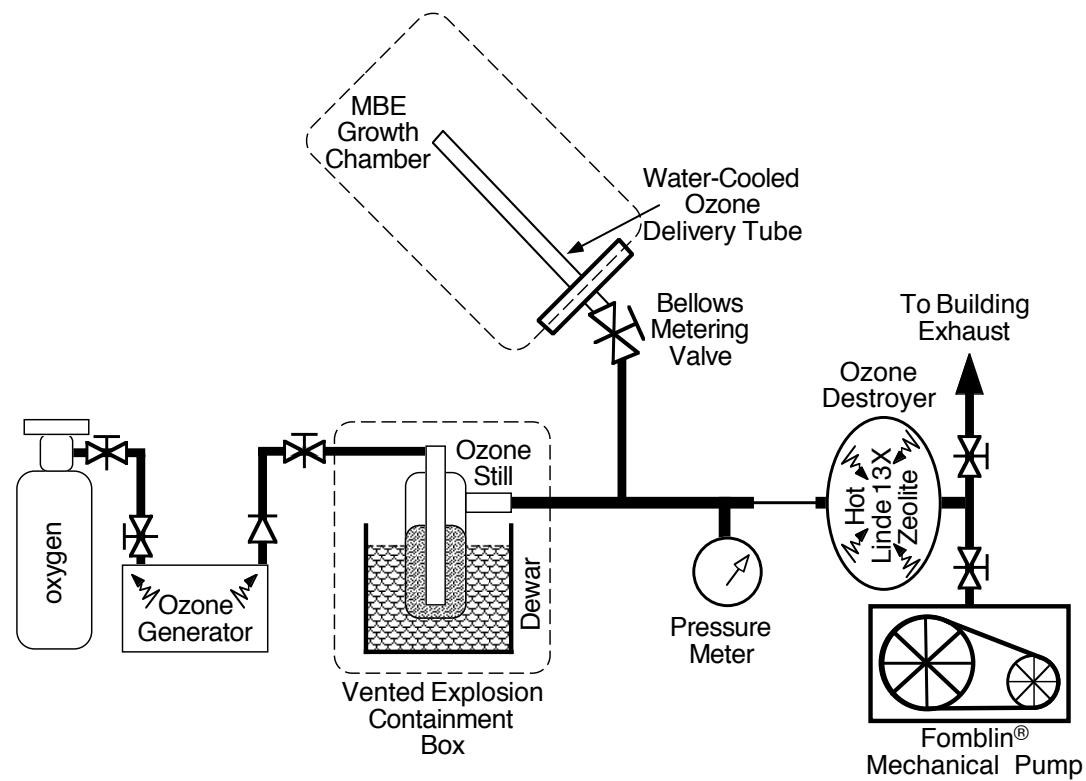
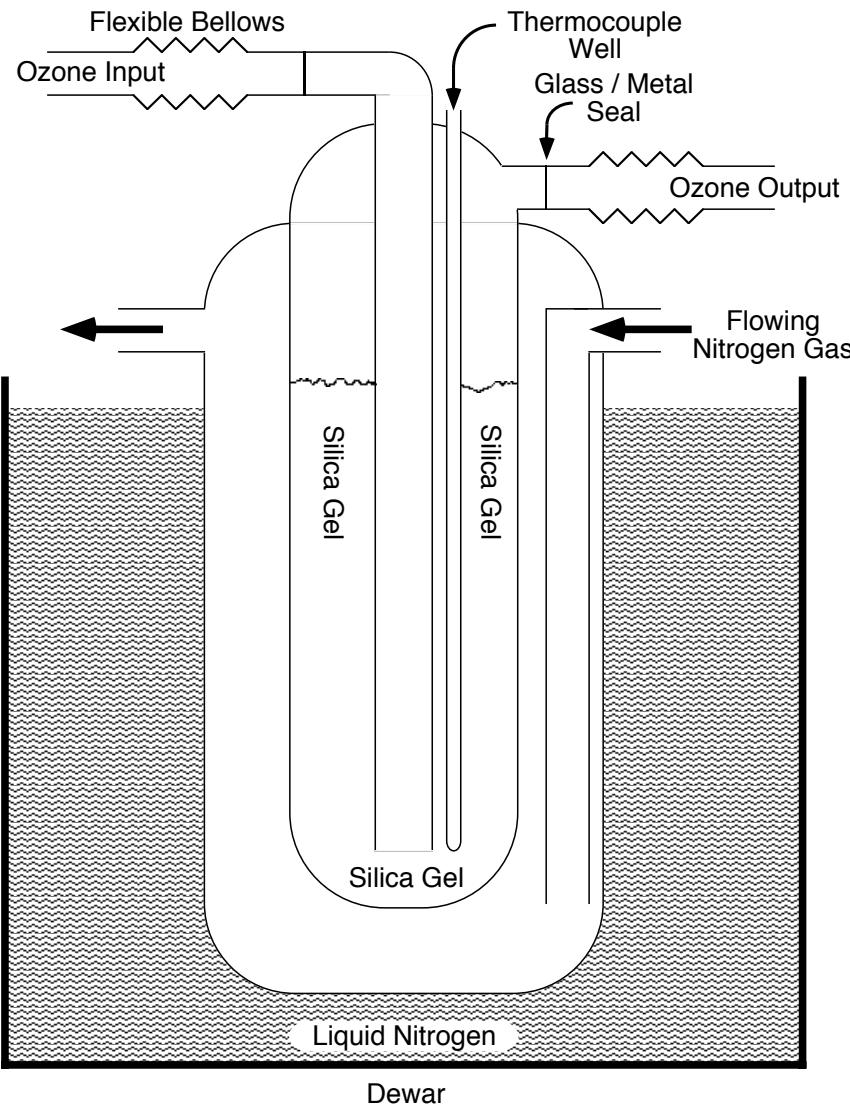
A piece of fine iron wire was placed in the bed of gel and ignited by passing an electric current through it. With a loading of 9 grams of ozone per 100 grams of gel, a test was made at -78° C . After ignition of the wire, a glow in the vessel was observed, but no explosion took place. With a loading of 20 grams of ozone per 100 grams of gel at -105° C . a dull pop was heard when the wire was ignited, most of the ozone changed to oxygen, and the gel was extensively pulverized. The glass container was broken but not shattered.

G.A. Cook, A.D. Kiffer, , C.V. Klumpp, A.H. Malik,
and L.A. Spence,

“Separation of Ozone from Oxygen
by a Sorption Process,” in:
Ozone Chemistry and Technology,

Vol. 21 of Advances in Chemistry Series, (American
Chemical Society, Washington, D.C., 1959) pp. 44-52.

Ozone in Silica Gel



Process Control



- Safety committee requirements led to development of fully integrated process controller
- Controller monitors all process equipment and parameters
- Countermeasures if close to critical limit
- Self-test of equipment before process start
- Fully automated operation
- No need to manually watch ozone process, user can focus on MBE growth!!!

Ozone System Passivation

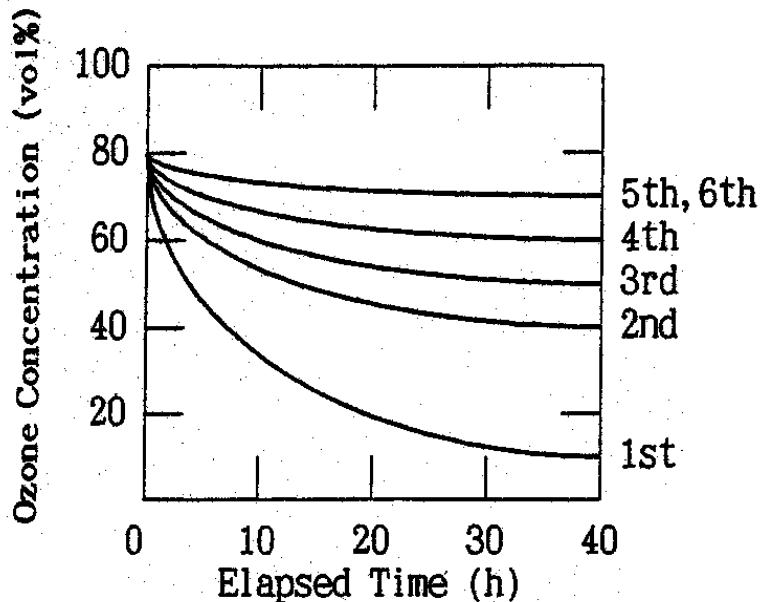


Fig. 2. Ozone concentration decay during ozone passivation.

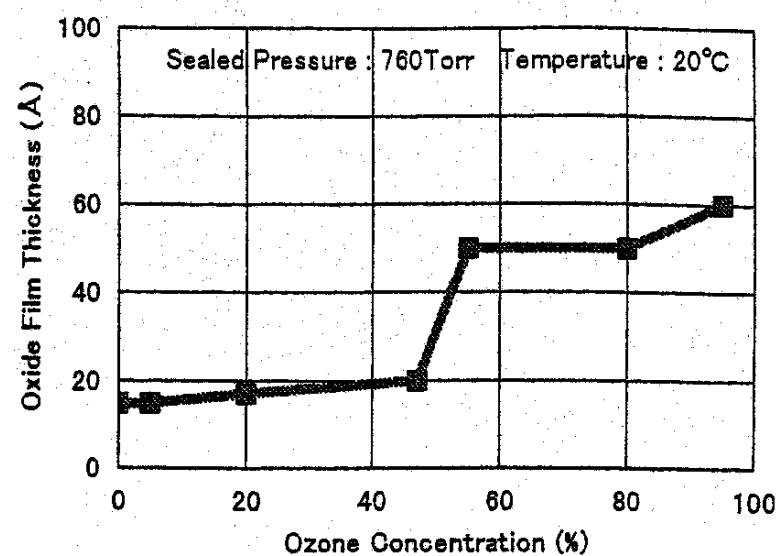


Fig. 4. Relationship of ozone concentration with thickness of passivated film formed at atmospheric pressure and 20°C.

Pros and Cons of Ozone

- Pros
 - Excellent Oxidant ($>10^3$ (experiment) to $<10^{12}$ (thermo) more powerful than O_2)
 - 80% Ozone (+20% O_2) delivered to the Substrate
 - No Energetic Species (thermal ozone beam)
 - Clean (lower in contaminants than plasma beam)
- Cons
 - Safety (Ozone still issues)
 - Safety (Pump issues)
 - Need Ozone-Compatible UHV Leak Valve
 - Need to Passivate Ozone System

If you want to grow EuO by MBE, what oxidant should you use?

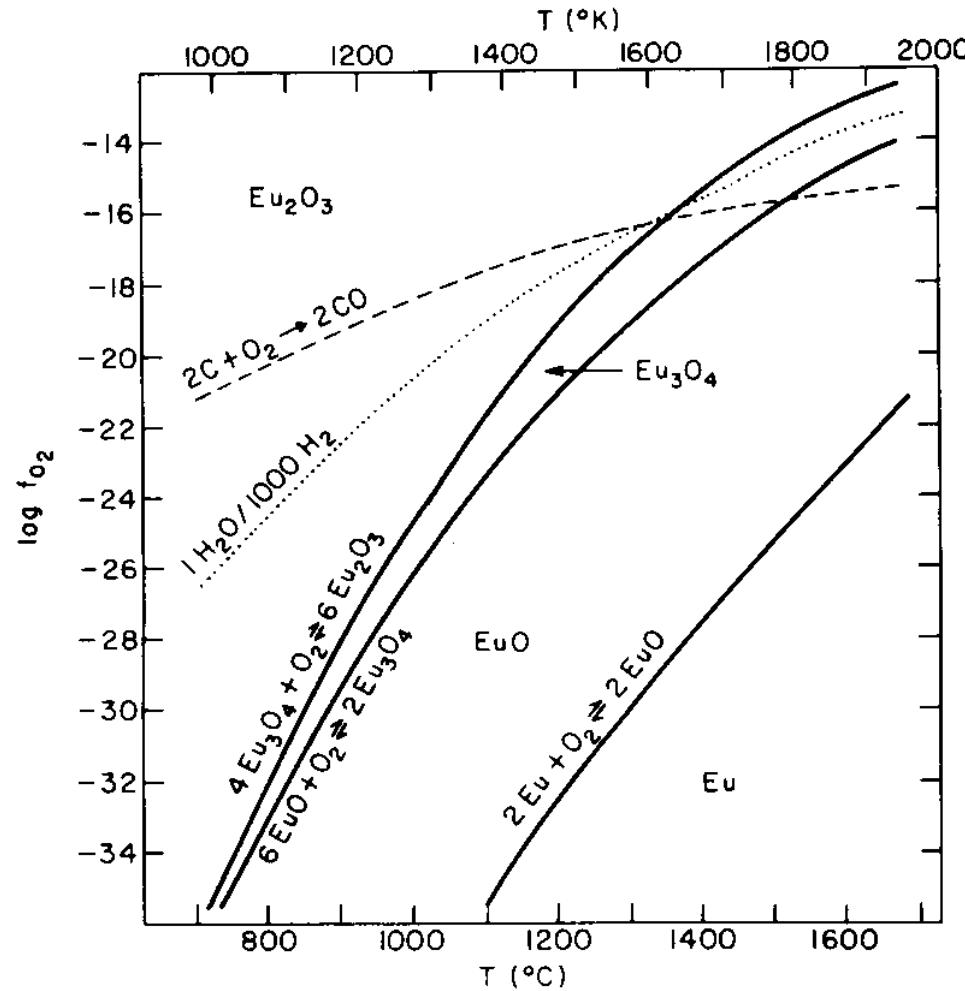


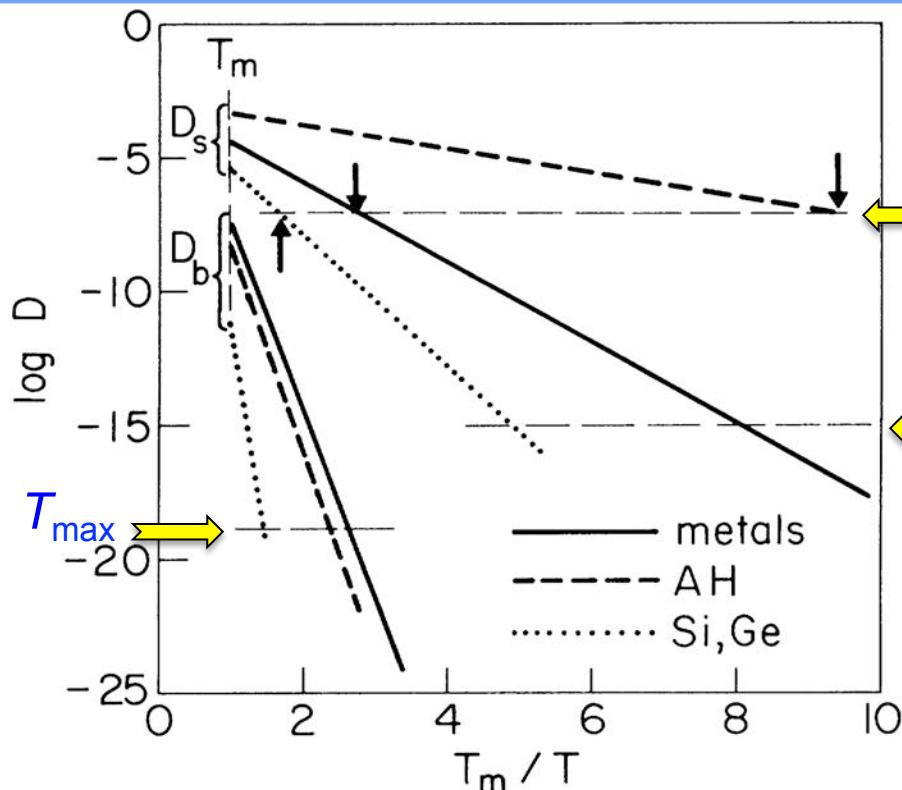
Fig. 1. Plot of $f_{\text{O}_2}(T)$ for oxidation reactions of Eu, EuO, and Eu_3O_4 and for C to CO and H_2 with 1 part/1000 H_2O .

G.J. McCarthy
“Oxygen-Fugacity-Temperature Diagram for the Eu-O System,”
Journal of the American Ceramic Society **57** (1974) 502.

Nuts and Bolts of Oxide MBE

- Mean Free Path (maximum P_{O_2})
- Minimum P_{O_2} , need for P_{O_3}
- Optimal T_{sub}
- MBE System
- MBE Sources
- Crucibles

Surface vs. Bulk Diffusion



Assuming growth rate of
0.1 monolayer/sec

T_{\min} for smooth epitaxial films
(growth by step propagation)

T_{\min} for epitaxy

Optimal Growth Temperatures

$0.55 < \frac{T_{\text{sub}}}{T_{\text{melt}}} < 0.7$ for semiconductors

$0.35 < \frac{T_{\text{sub}}}{T_{\text{melt}}} < 0.4$ for metals

$0.1 < \frac{T_{\text{sub}}}{T_{\text{melt}}} < 0.4$ for simple ceramics

FIG. 6. Diagram showing deduced global dependences of surface and bulk diffusion coefficients, D_s and D_b , on T_m/T for metals (solid lines), elemental semiconductors (dotted lines), and salts (dashed lines). The construction is described in the text. Smooth flat interfaces generally require $D_s \gtrsim 10^{-8}-10^{-7} \text{ cm}^2/\text{sec}$, which fixes the lowest growth temperatures (arrows) as $\sim 3T_m/8$, $0.55T_m$, and $0.1T_m$ in the three cases. RHEED oscillations are expected for $D_s \gtrsim 10^{-15} \text{ cm}^2/\text{sec}$ and bulk interdiffusion for $D_b \gtrsim 10^{-19} \text{ cm}^2/\text{sec}$.

M.H. Yang and C.P. Flynn
Physical Review Letters **62** (1989) 2476-2479.



Universal Diffusion Behavior of Metals

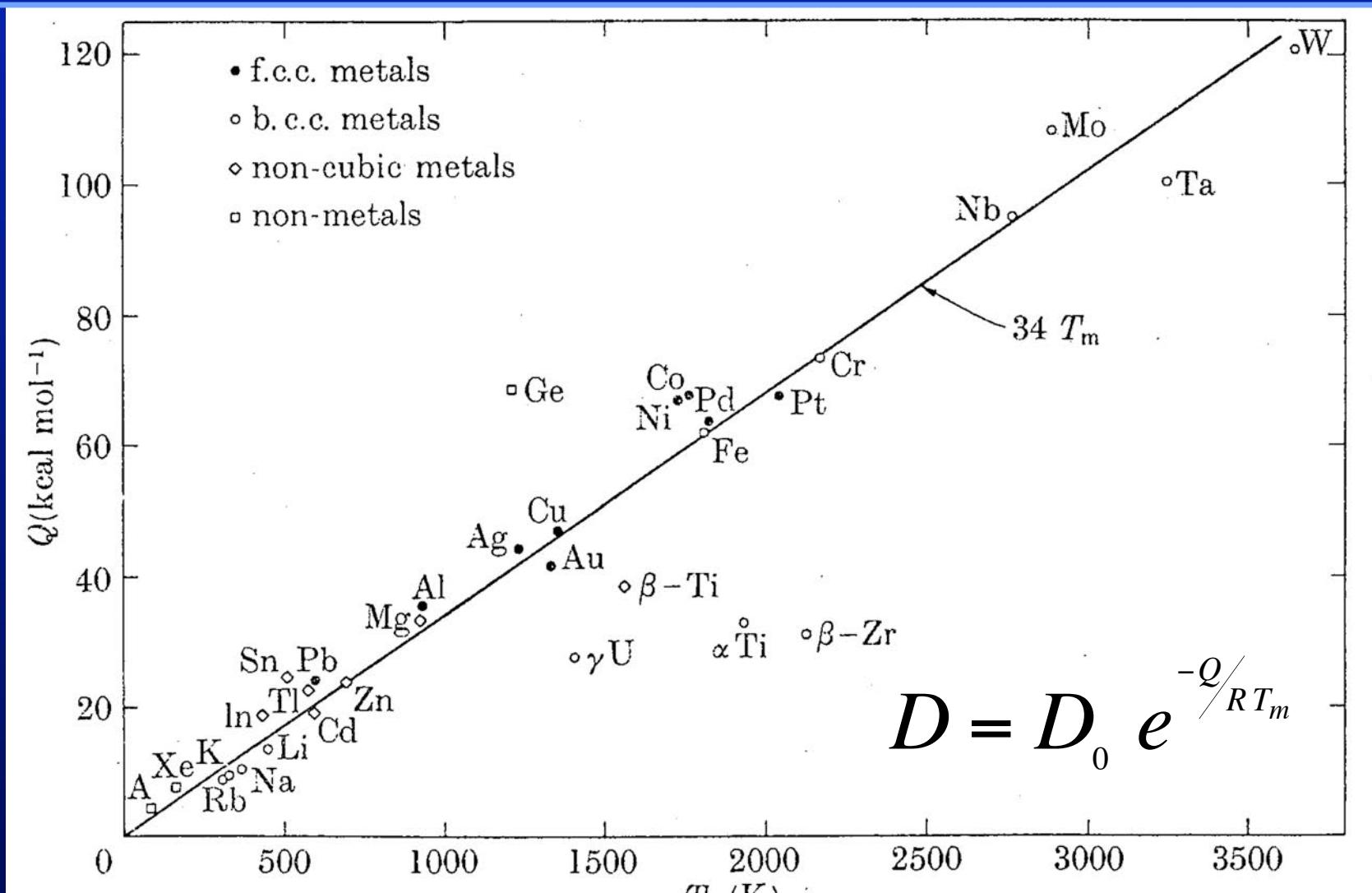
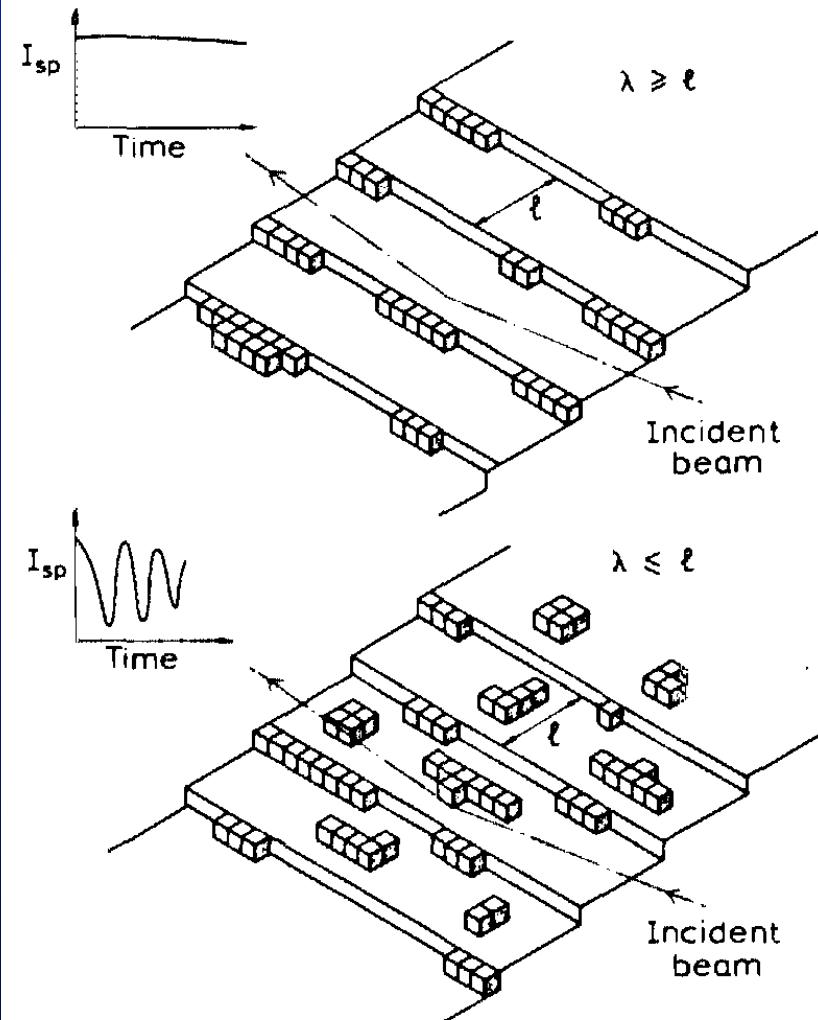


FIG. 14.31. The correlation between Q and T_m .

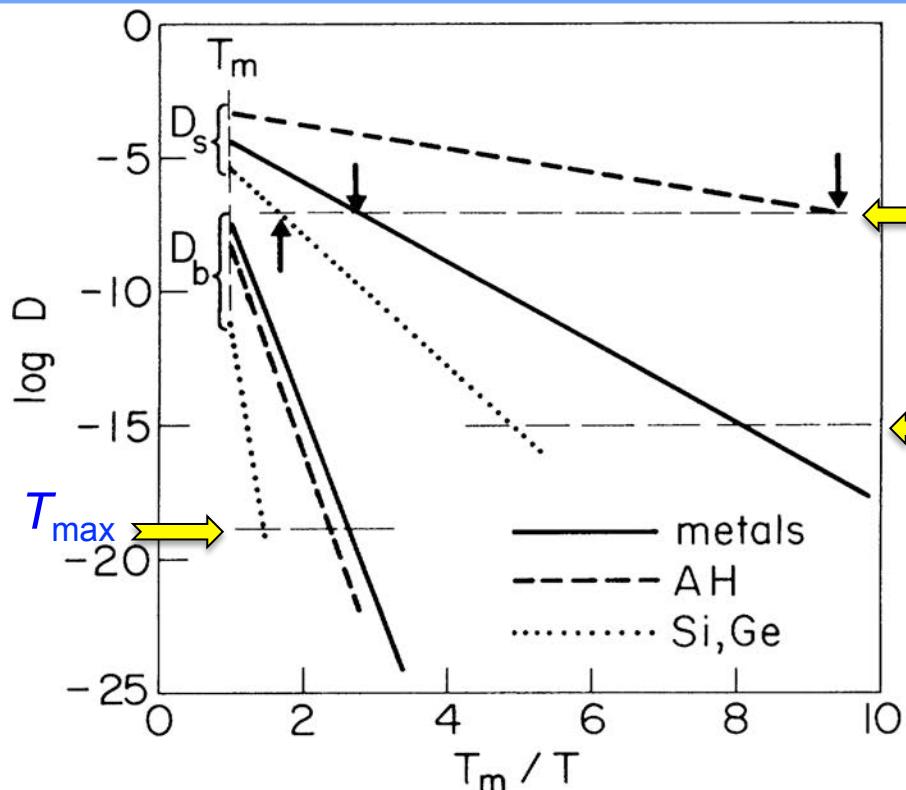
Determining Surface Diffusion from RHEED Oscillations



J.H. Neave, P.J. Dobson,
B.A. Joyce, and J. Zhang,
Applied Physics Letters **47**
(1985) 100-102.

FIG. 1. Schematic illustration of the principle of the method, showing the change in RHEED information as the growth mode changes from "step flow" to 2-D nucleation. Steps lie along [100].

Surface vs. Bulk Diffusion



Assuming growth rate of
0.1 monolayer/sec

T_{\min} for smooth epitaxial films
(growth by step propagation)

T_{\min} for epitaxy

Optimal Growth Temperatures

$0.55 < \frac{T_{\text{sub}}}{T_{\text{melt}}} < 0.7$ for semiconductors

$0.35 < \frac{T_{\text{sub}}}{T_{\text{melt}}} < 0.4$ for metals

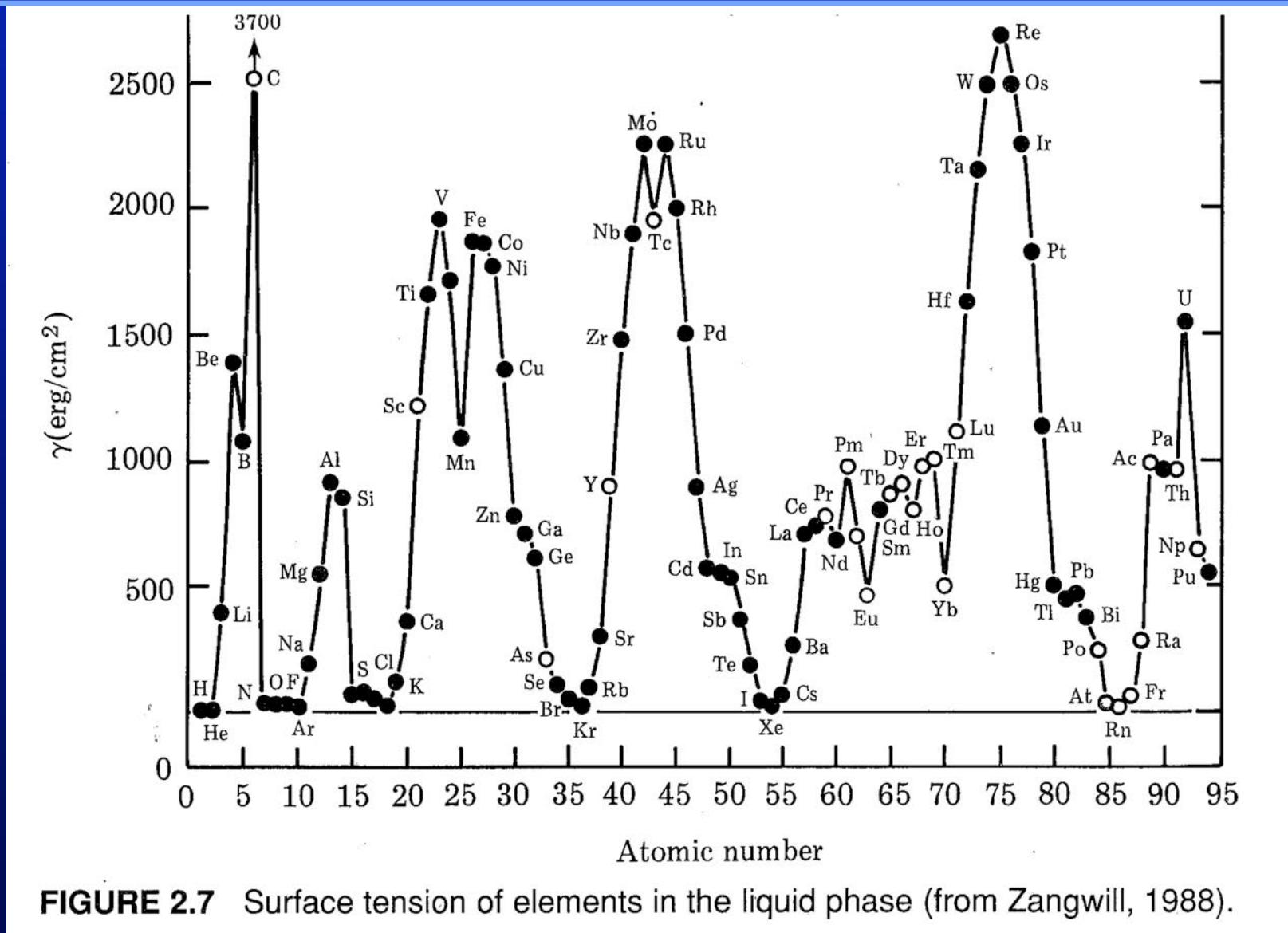
$0.1 < \frac{T_{\text{sub}}}{T_{\text{melt}}} < 0.4$ for simple ceramics

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M.H. Yang and C.P. Flynn
Physical Review Letters **62** (1989) 2476-2479.



Surface Energy Considerations



TEM of MBE-Grown Superlattices

AlAs / GaAs

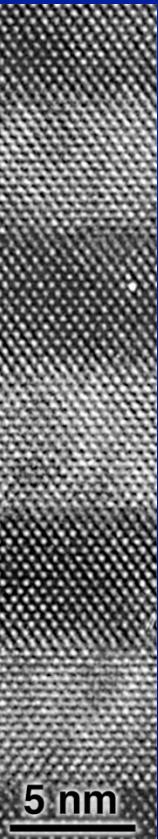
AlAs

GaAs

AlAs

GaAs

AlAs



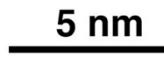
PbTiO₃ / SrTiO₃

SrTiO₃
PbTiO₃
SrTiO₃
PbTiO₃
SrTiO₃



BaTiO₃ / SrTiO₃

SrTiO₃
BaTiO₃
SrTiO₃
BaTiO₃
SrTiO₃
BaTiO₃
SrTiO₃
BaTiO₃
SrTiO₃
BaTiO₃



A.K. Gutakovskii *et al.*,
Phys. Stat. Sol. (a) **150** (1995) 127.

PARADIM

C.D. Theis
(1st Generation Schlom Group)
HRTEM—Pan Group (Michigan)
D.G. Schlom *et al.*, Mater. Sci. Eng. B **87** (2001) 282.

J.H. Haeni
(2nd Generation)
NSF



From the observed morphology,
which likely has the
higher surface energy?

- (a) GaAs
- (b) AlAs
- (c) They appear to have the same surface energies

Thermodynamic Considerations

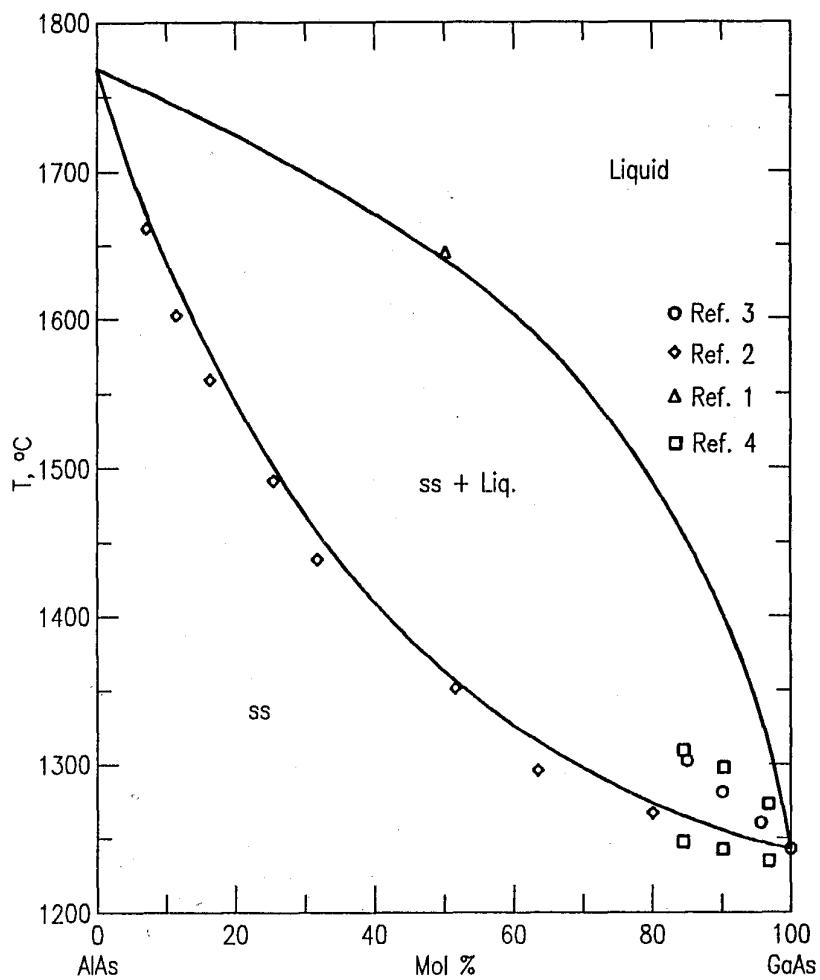


Fig. 8343—Pseudobinary system AlAs-GaAs.
K. Y. Ma, S. H. Li, and G. B. Stringfellow, "P, As, and Sb Phase Diagrams", Special Report to the Standard Reference Data Program, National Institute of Standards and Technology; Gaithersburg, Maryland (1987).

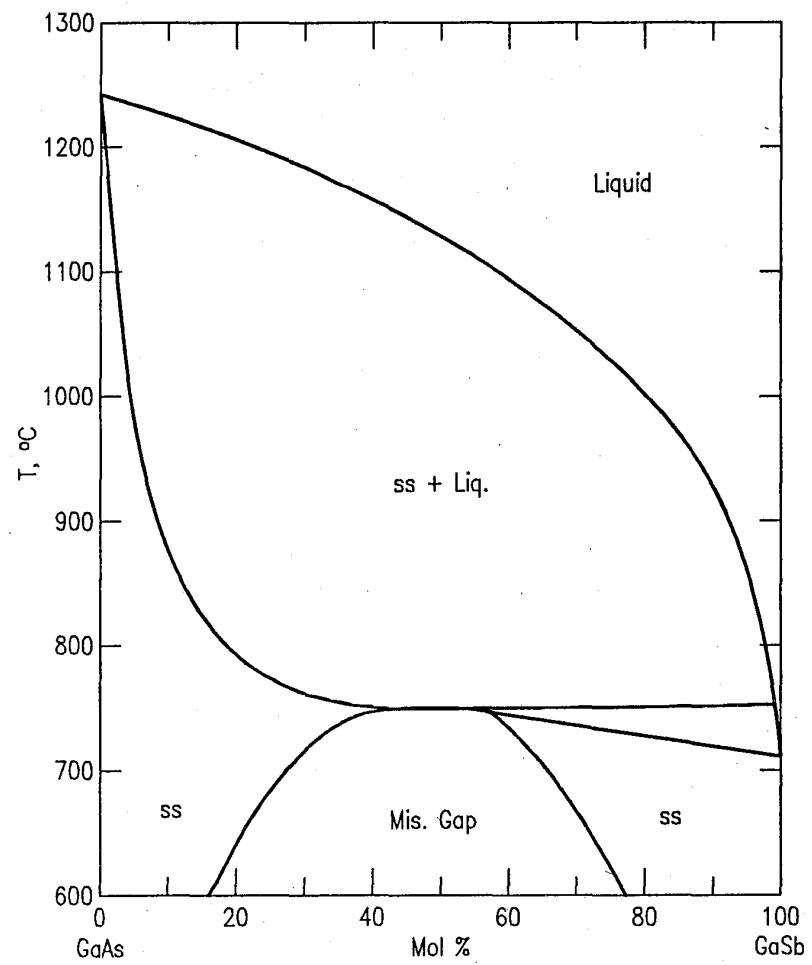


Fig. 8362—Pseudobinary system GaAs-GaSb. Calculated diagram.
K. Y. Ma, S. H. Li, and G. B. Stringfellow, "P, As, and Sb Phase Diagrams", Special Report to the Standard Reference Data Program, National Institute of Standards and Technology; Gaithersburg, Maryland (1987).

Thermodynamic Considerations

Increased Interface Roughness and Clustering at Non-Optimal Growth Conditions

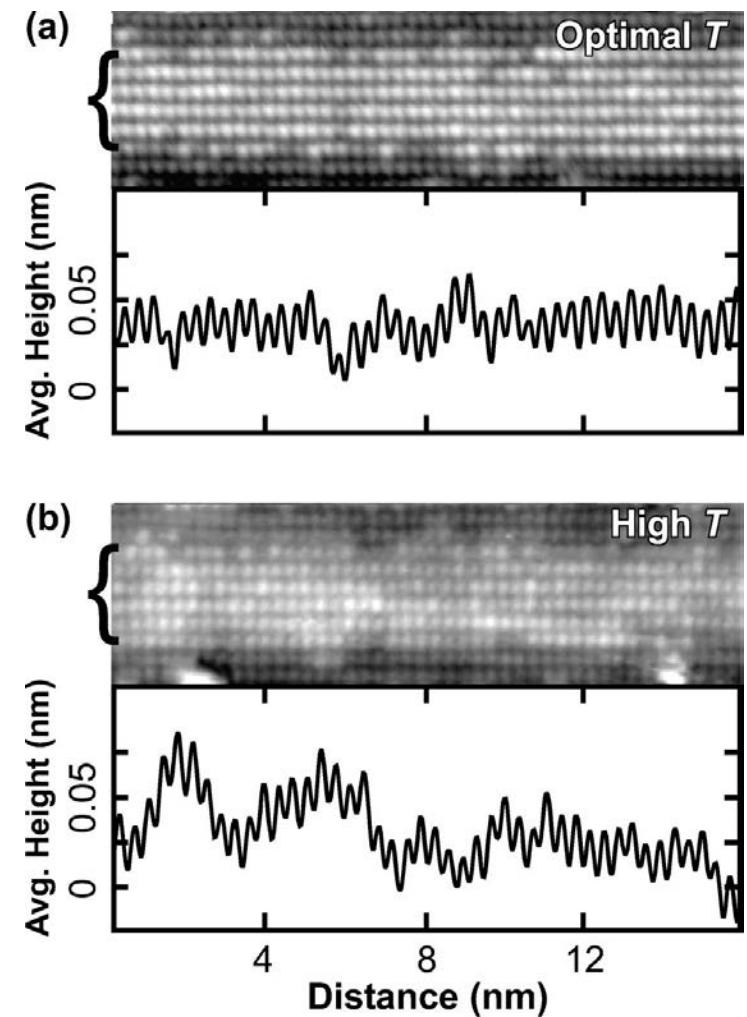
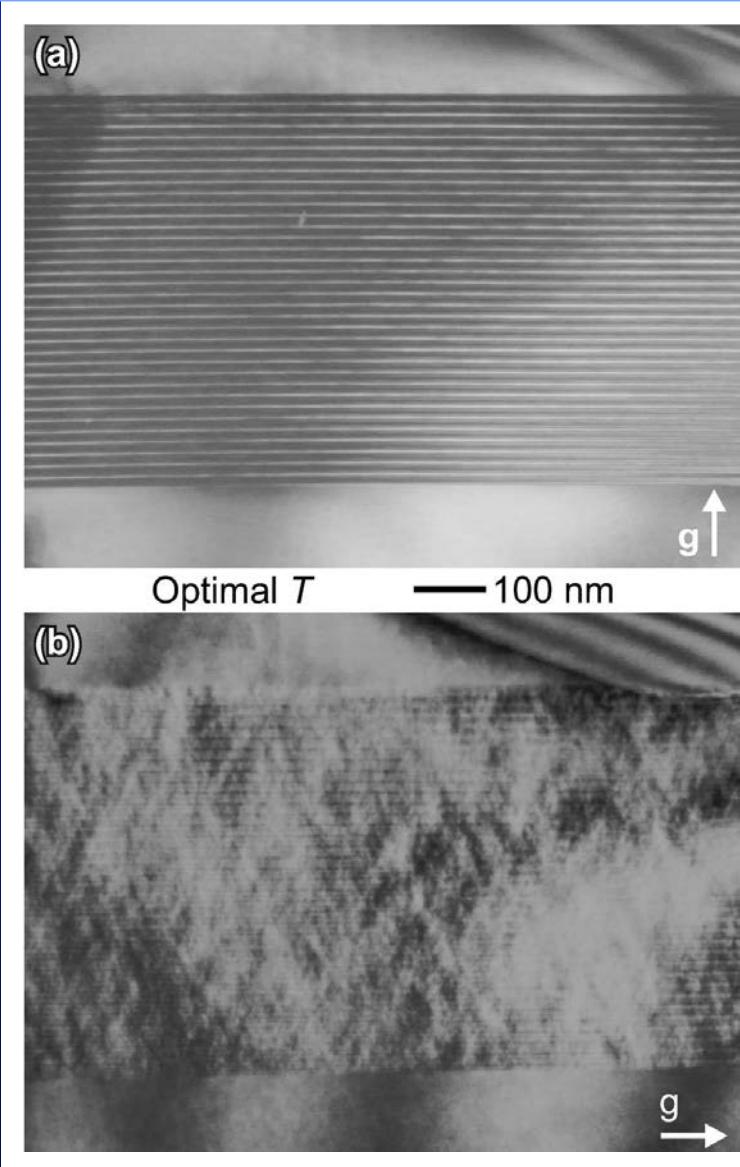
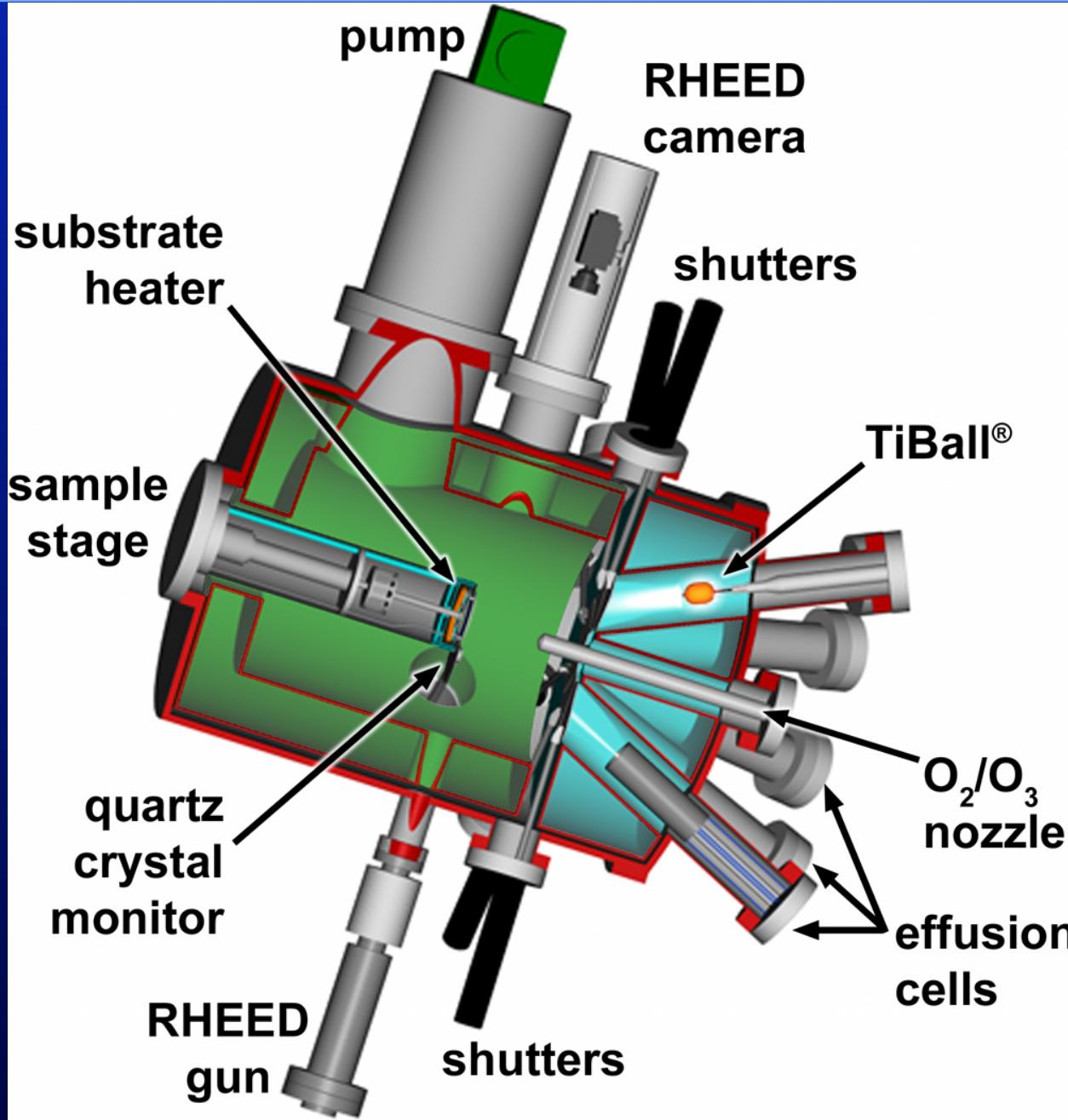


FIG. 6. XSTM images and average-height profiles for InGaSb-alloy layers in an (a) optimal- and (b) high-temperature sample. (a) -2.0 V, 50 pA and (b) -2.5 V, 0.5 nA.

Nuts and Bolts of Oxide MBE

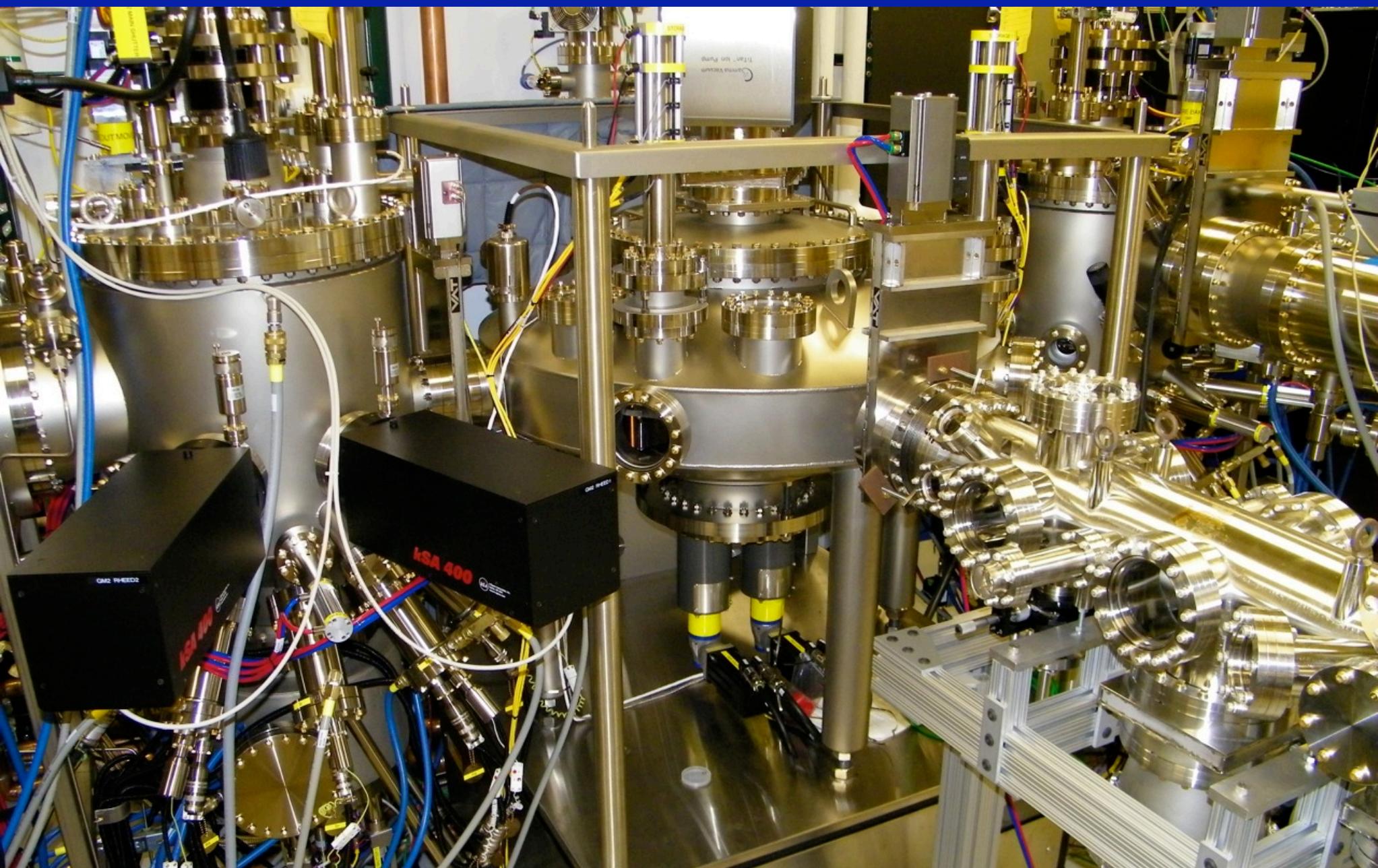
- Mean Free Path (maximum P_{O_2})
- Minimum P_{O_2} , need for P_{O_3}
- Optimal T_{sub}
- MBE System
- MBE Sources
- Crucibles

Oxide MBE System

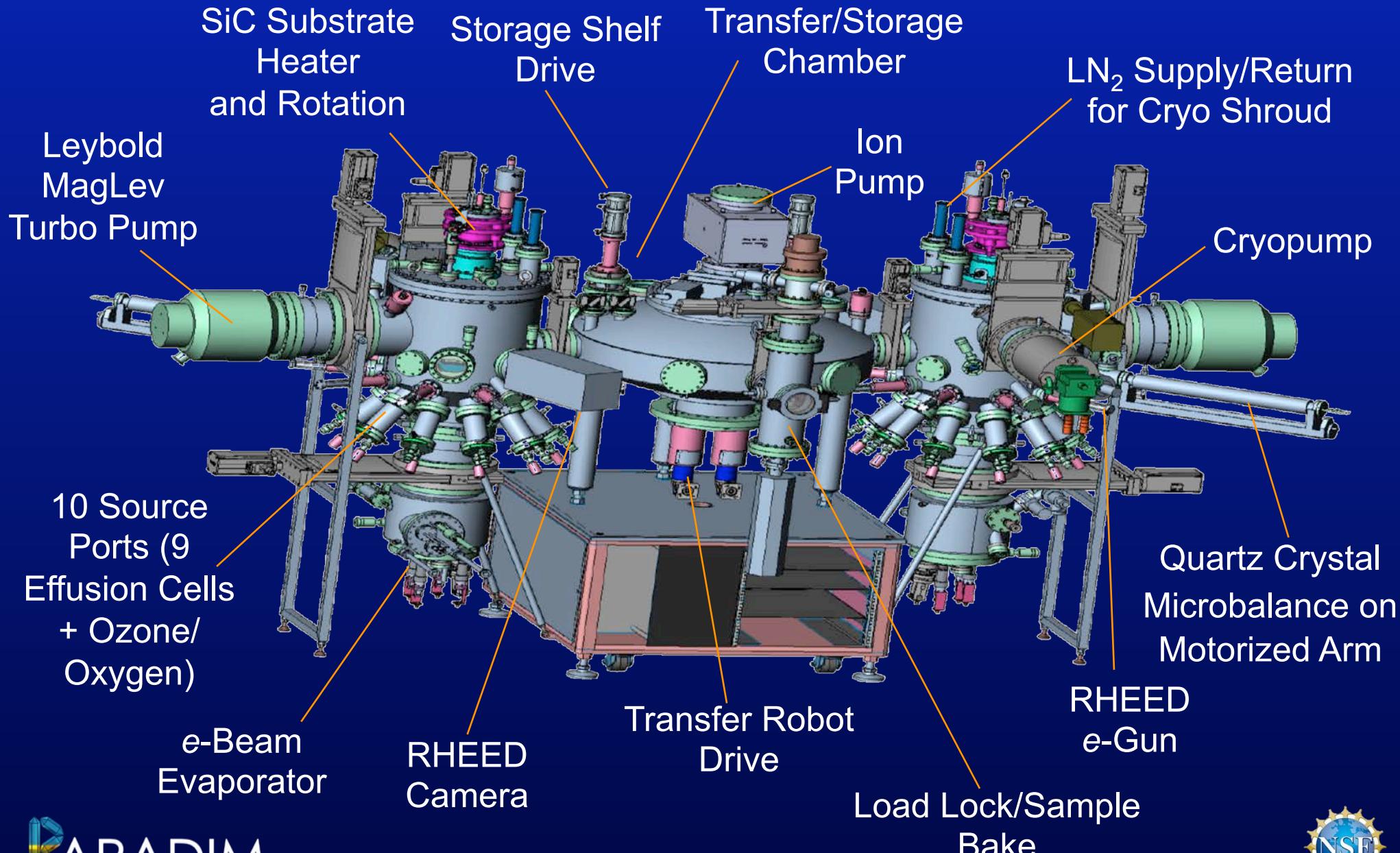


Oxide MBE + ARPES

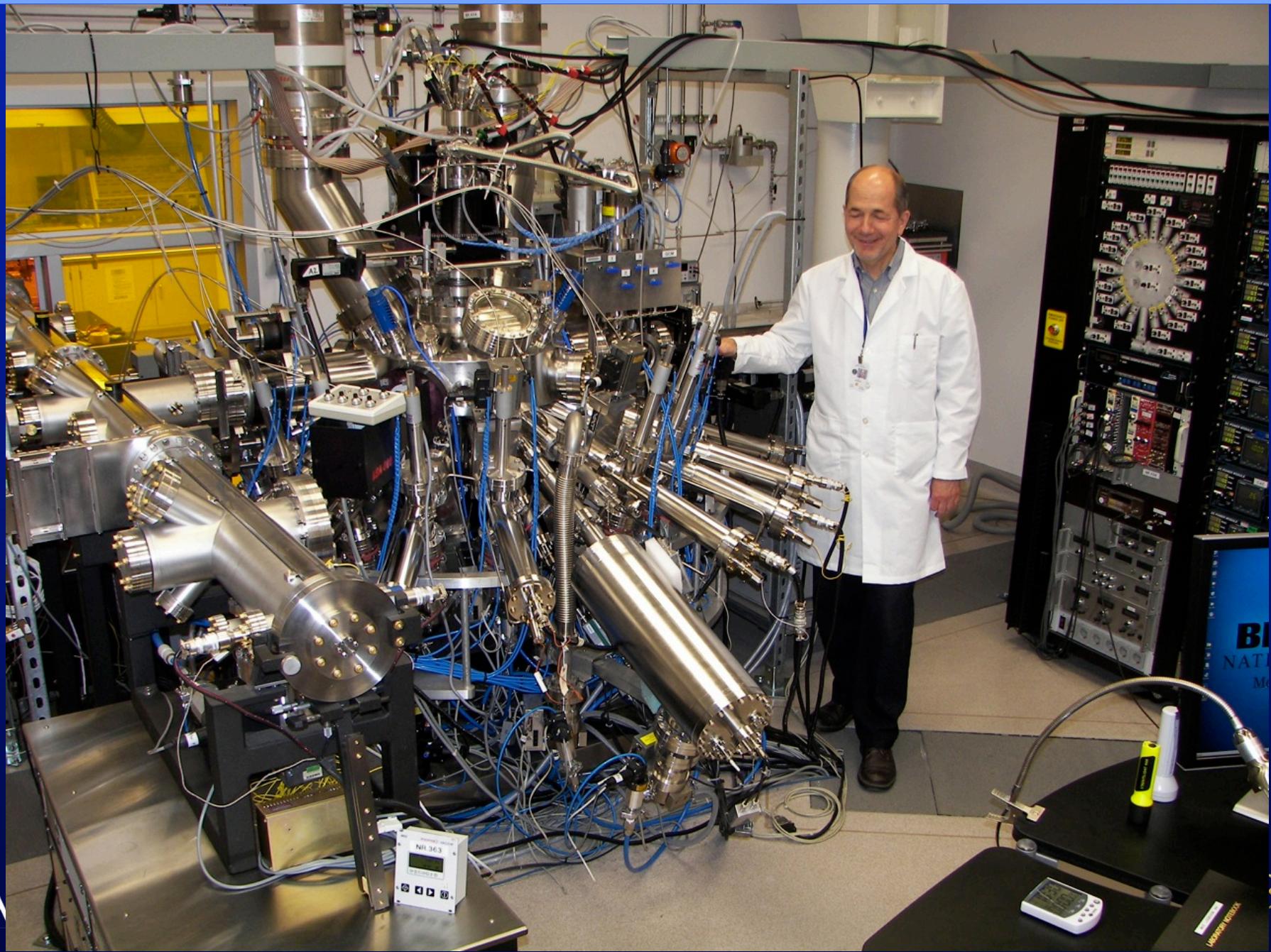
Collaboration with Kyle Shen (Cornell, Physics)



Automated Veeco GEN10 Oxide MBE



Oxide MBE at Brookhaven Nat. Lab.



Sources for Oxide MBE



- **Effusion cell**
(resistively heated thermal evaporators, up to 2000 °C), material in crucible
- **Ti-Ball™ source**
titanium sphere with resistive heater inside
- **e-gun evaporator**
for extremely low vapor pressure materials
(W, Ru, etc.)

Ti-Ball™ Source

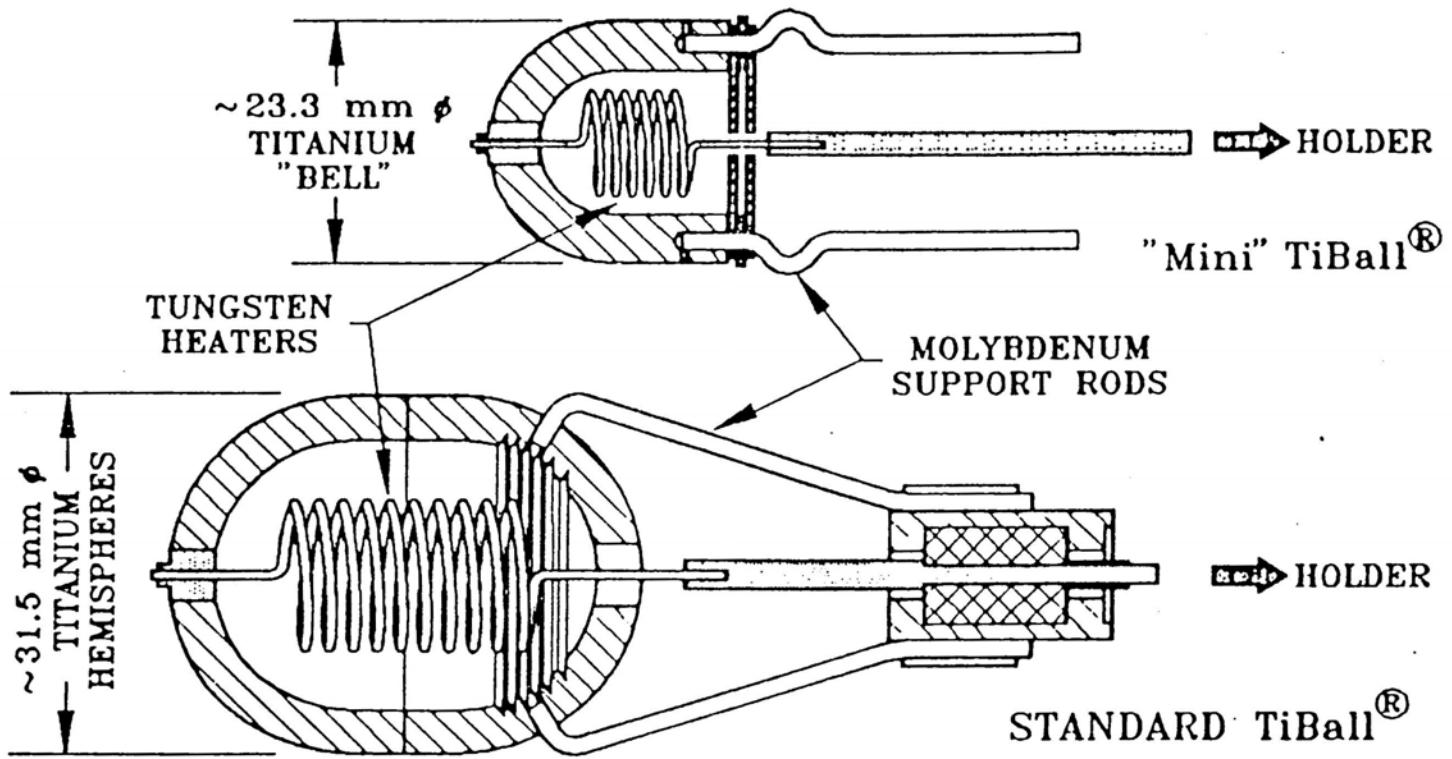


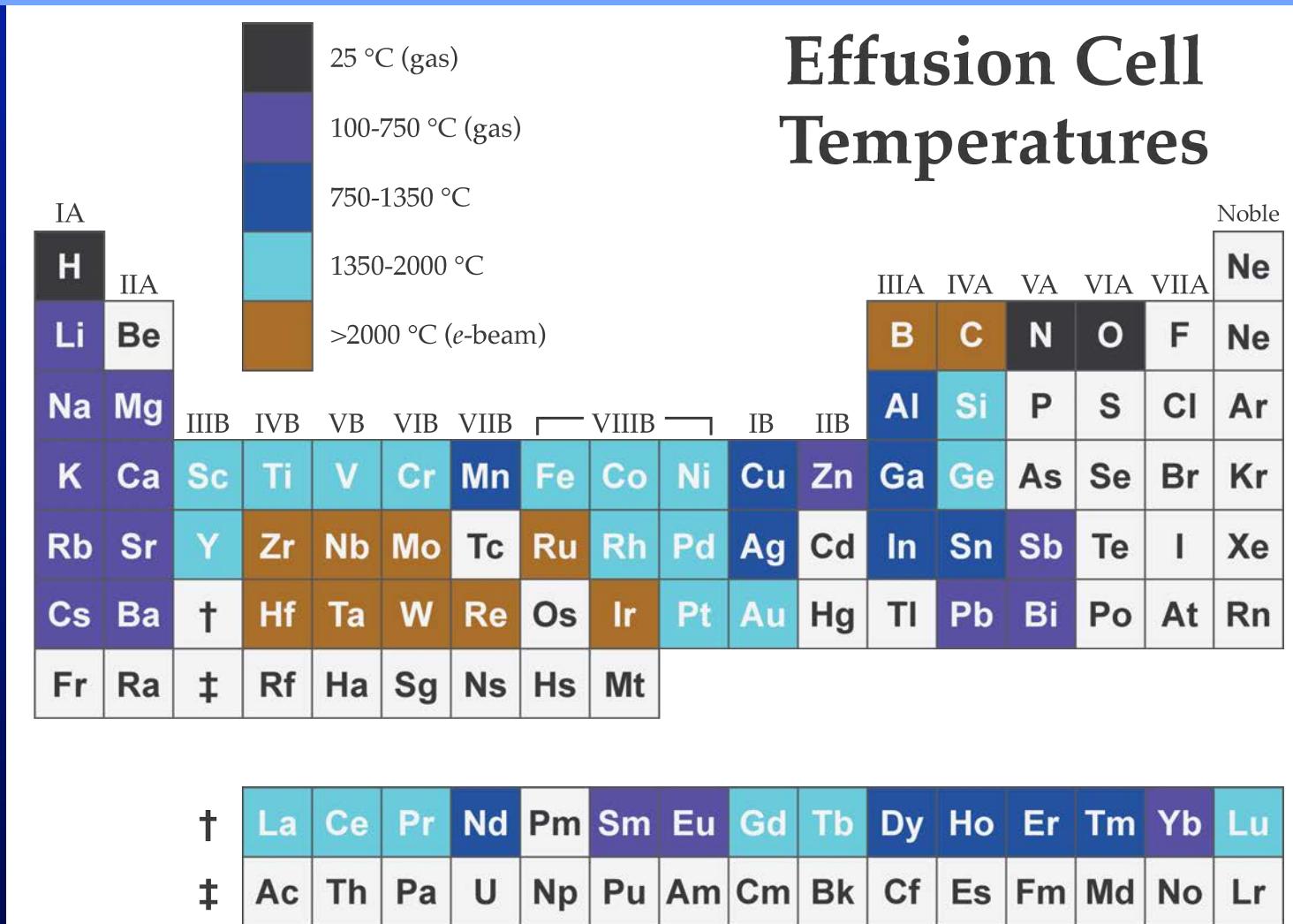
Figure 3.4.4. Two varieties of radiantly heated sublimation sources; the TiBall®, developed by Harra and Snouse⁽⁴²⁾ and a smaller, radiantly heated source developed by Welch.

CAPTURE PUMPING TECHNOLOGY

An Introduction

KIMO M. WELCH
Brookhaven National Laboratory, Upton, NY, USA

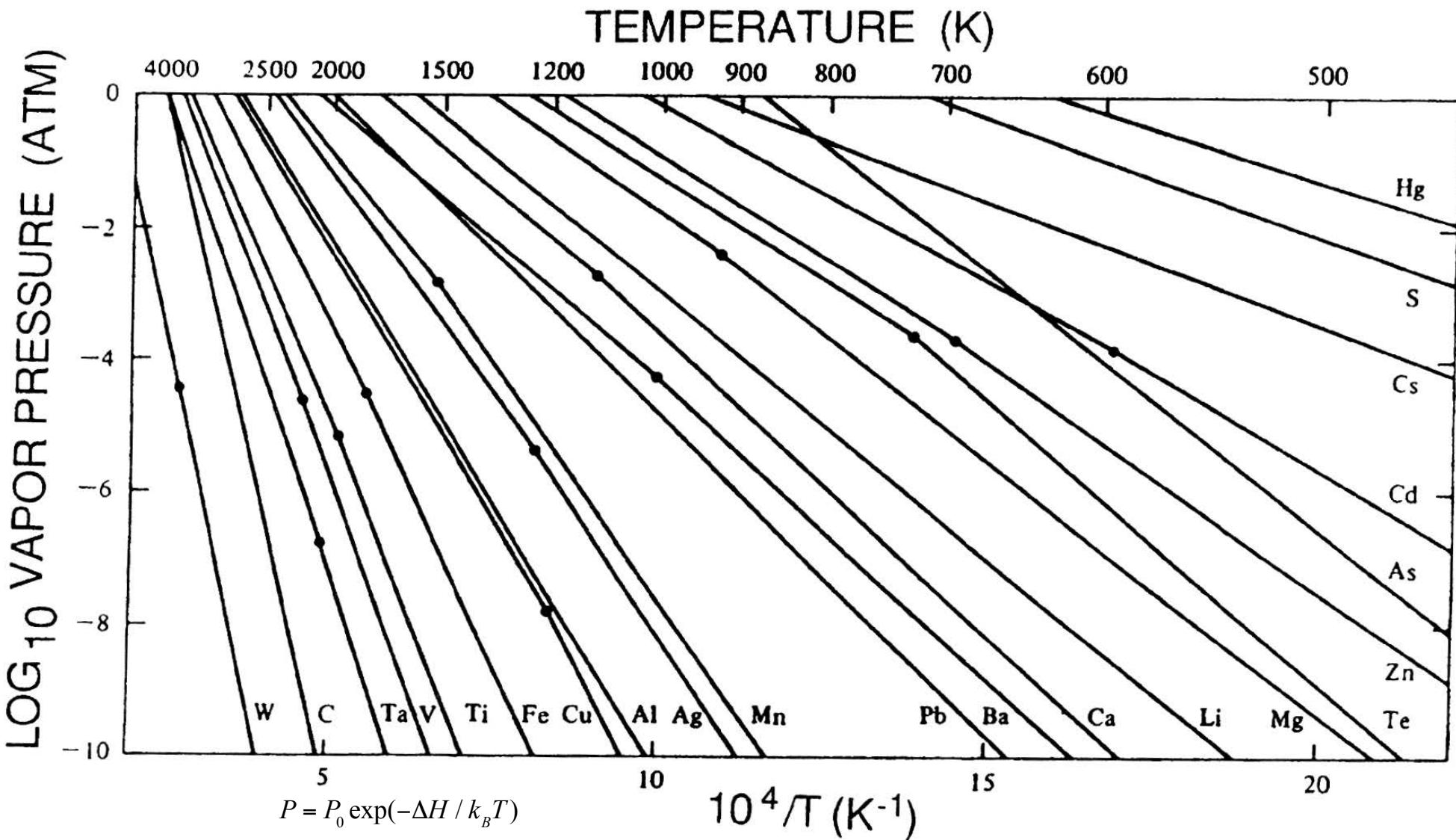
MBE Effusion Cells for Different Temperatures



MBE Effusion Cells



Arrhenius Plot of Vapor Pressure

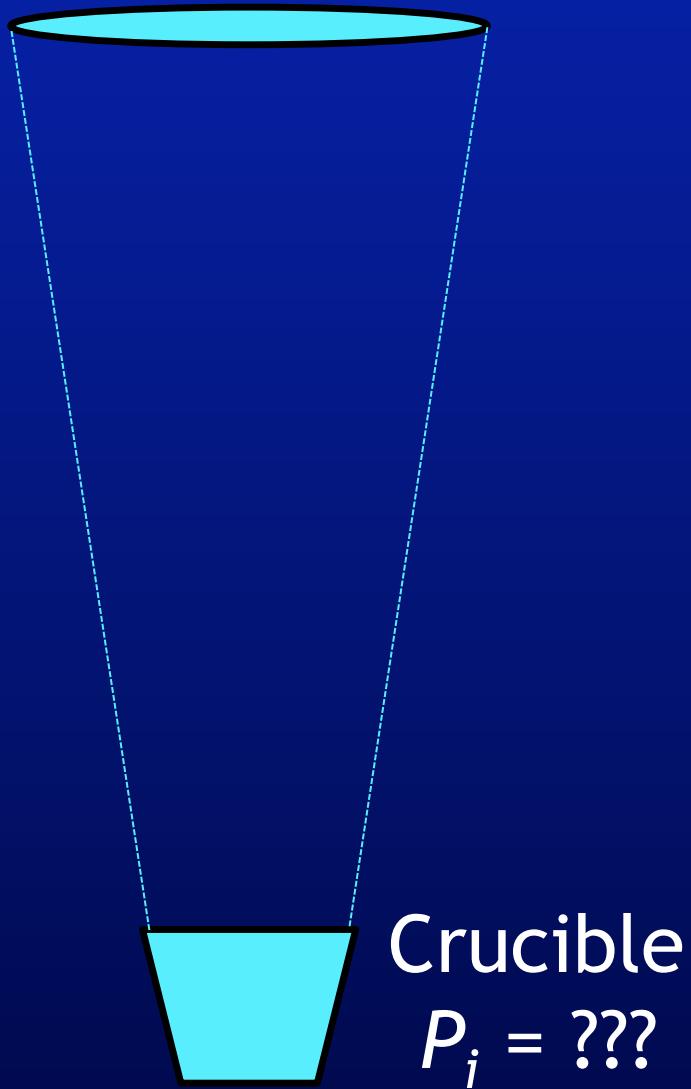


$$\ln P = \ln P_0 - \left(\frac{\Delta H}{k_B} \right) \cdot \left(\frac{1}{T} \right)$$

so plot $\log(P)$ vs $1/T$: straight line if ΔH is constant
(note small or no change in slope at melting point)

What Vapor Pressure Needed?

Substrate (growth rate = 0.1 monolayers/s)



Crucible
 $P_i = ???$

$$\Phi_{Sr} = (0.1) \frac{1 \text{ Sr atom}}{(3.905 \text{ \AA})^2} \text{ s}^{-1} = 6.6 \times 10^{13} \frac{\text{atoms}}{\text{cm}^2 \text{ s}}$$

for SrTiO_3

From kinetic theory of gases:

$$\Phi = \frac{P}{\sqrt{2\pi m k_B T}} \quad \begin{aligned} &\text{for Sr, } m = 87.6 \text{ amu} \\ &\text{and } T \approx 1000 \text{ K} \end{aligned}$$

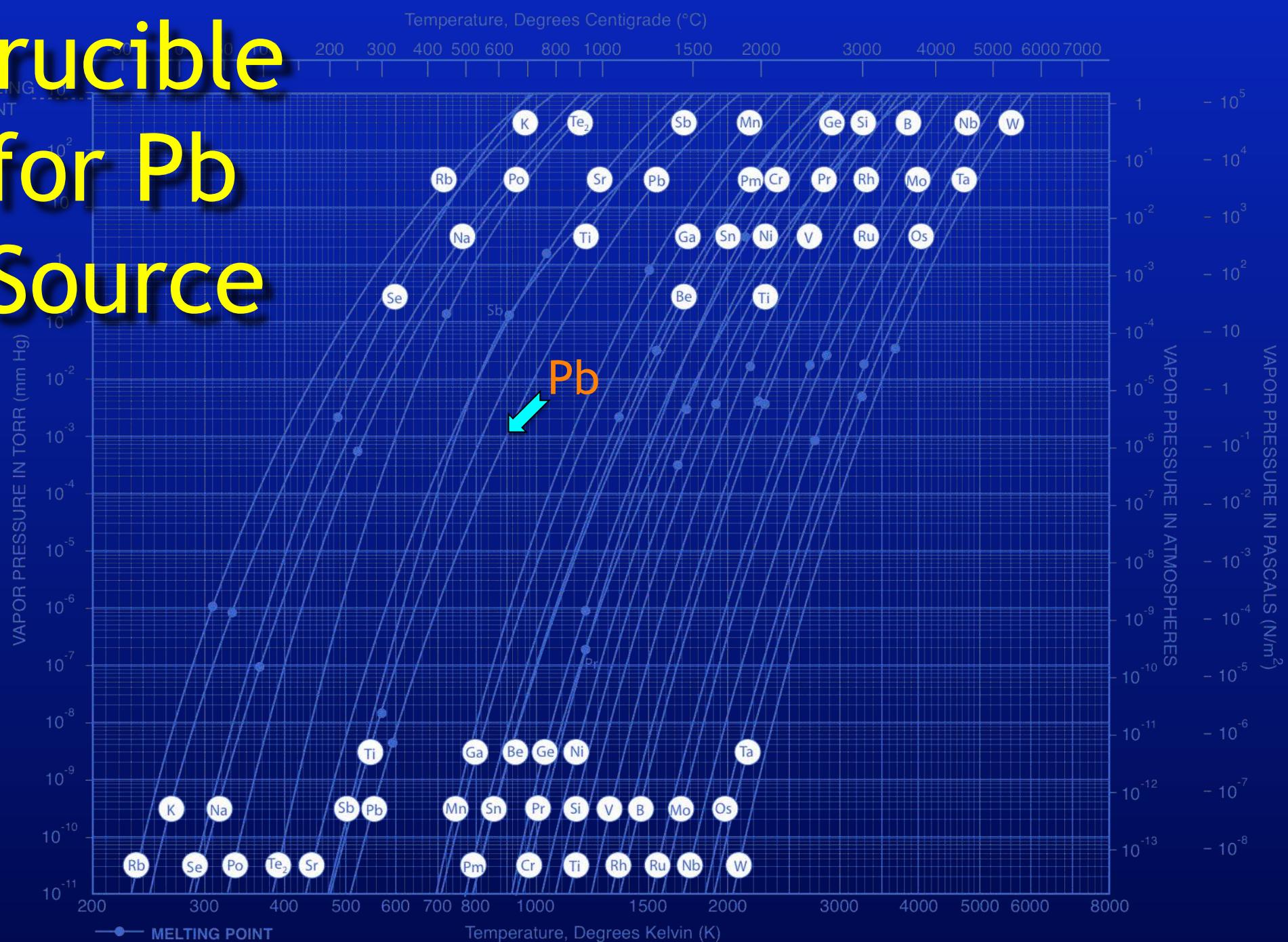
Above is maximum evaporation rate. For free evaporation (as in MBE where wide-mouth (Langmuir) sources are used)

$$\Phi = \frac{\alpha P}{\sqrt{2\pi m k_B T}} \quad \begin{aligned} &\alpha \approx 0.1 \\ &\text{(coefficient of evaporation)} \end{aligned}$$

Vapor pressure P_i needs to be larger by ratio of surface area of substrate to surface area of crucible

$$P_i = \frac{\Phi \sqrt{2\pi m k_B T}}{\alpha} (\text{area ratio}) \approx 10^{-4} - 10^{-3} \text{ Torr}$$

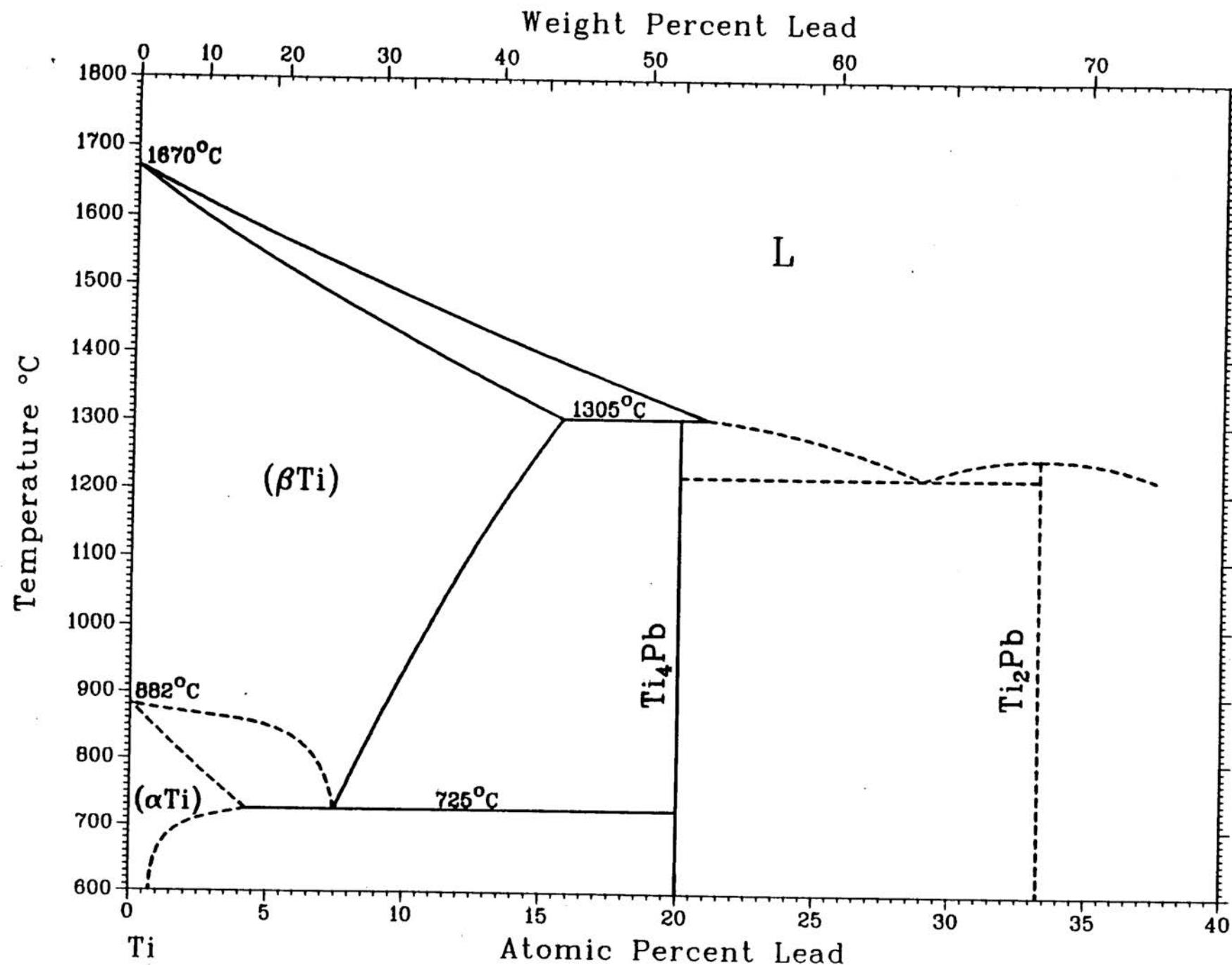
Crucible for Pb Source





Ti-Pb Phase Diagram

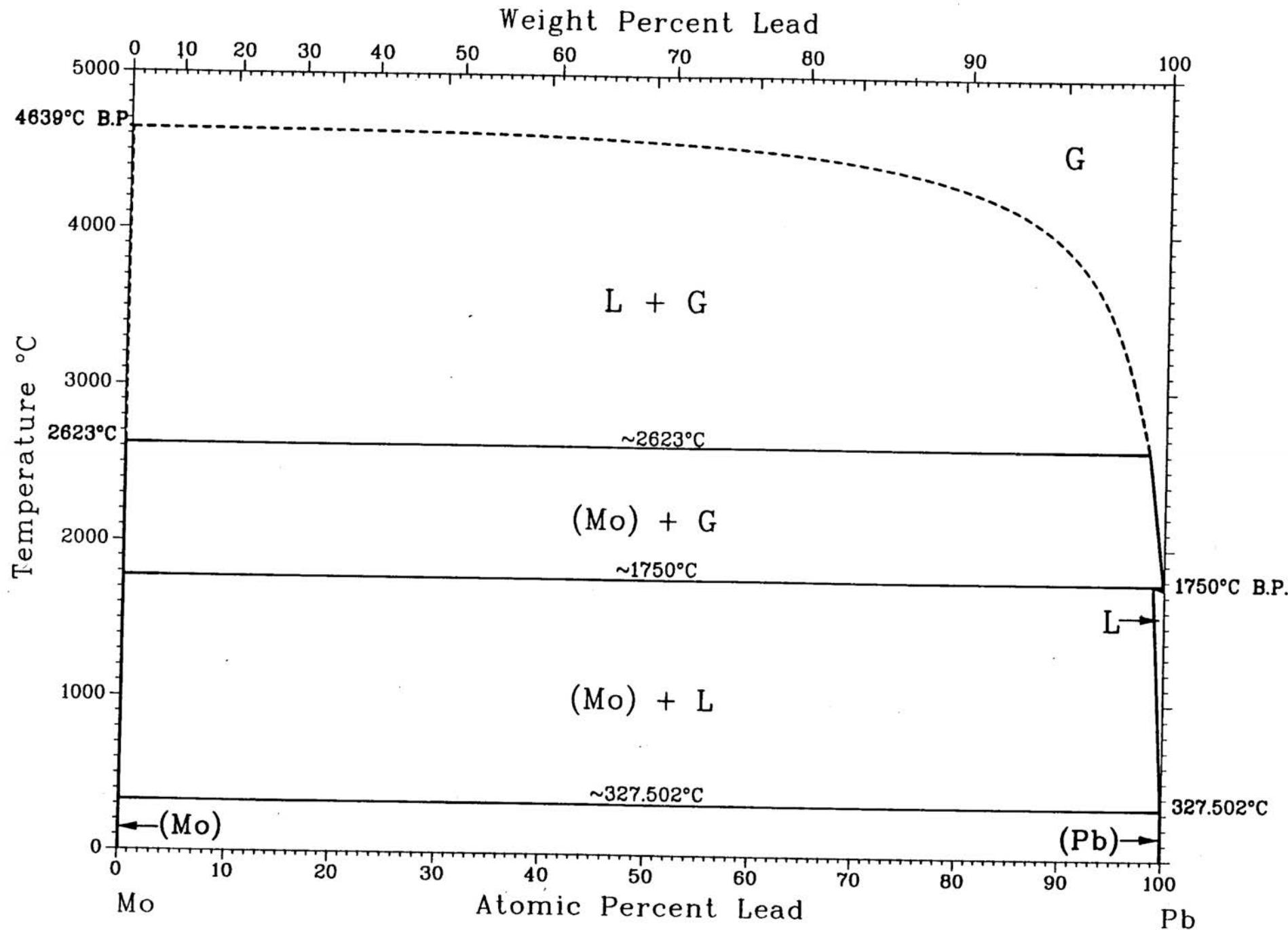
Binary Alloy Phase Diagrams,
edited by T.B. Massalski (ASM International, 1990).





Mo-Pb Phase Diagram

Binary Alloy Phase Diagrams,
edited by T.B. Massalski (ASM International, 1990).



Pb-W (Lead-Tungsten)

S.V. Nagender Naidu and P. Rama Rao

 No phase diagram is available for the Pb-W system. The solubility of W in liquid Pb is less than 0.1 at.% W. No intermediate phases exist in the system.

[19Ino] claimed to have determined the solidification temperature of alloys containing up to 30 at.% W at 1300 °C; however, no further details are available in this regard. The findings of [19Ino] are not accepted here because there is no confirming evidence in any of the later experimental investiga-

Pb-W Crystal Structure Data

Phase	Composition, at.% W	Pearson symbol	Space group	Struktur- bericht designation	Prototype
(Pb).....	~0	<i>cF</i> 4	<i>Fm</i> $\bar{3}m$	<i>A</i> 1	Cu
(W).....	~100	<i>cI</i> 2	<i>Im</i> $\bar{3}m$	<i>A</i> 2	W

tions as to the alloy formation.

19Ino: S. Inouye, *Mem. Coll. Sci. Kyoto Univ.*, 4, 43-46 (1919) in German.

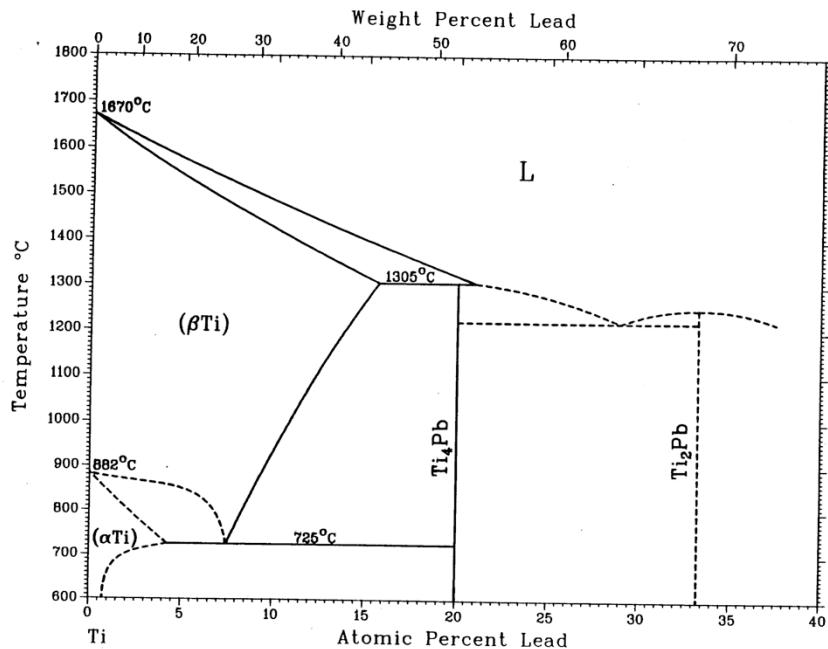
To be published in *Phase Diagrams of Bi-*

nary Tungsten Alloys, 1991. Complete evaluation contains 1 table and 11 references.

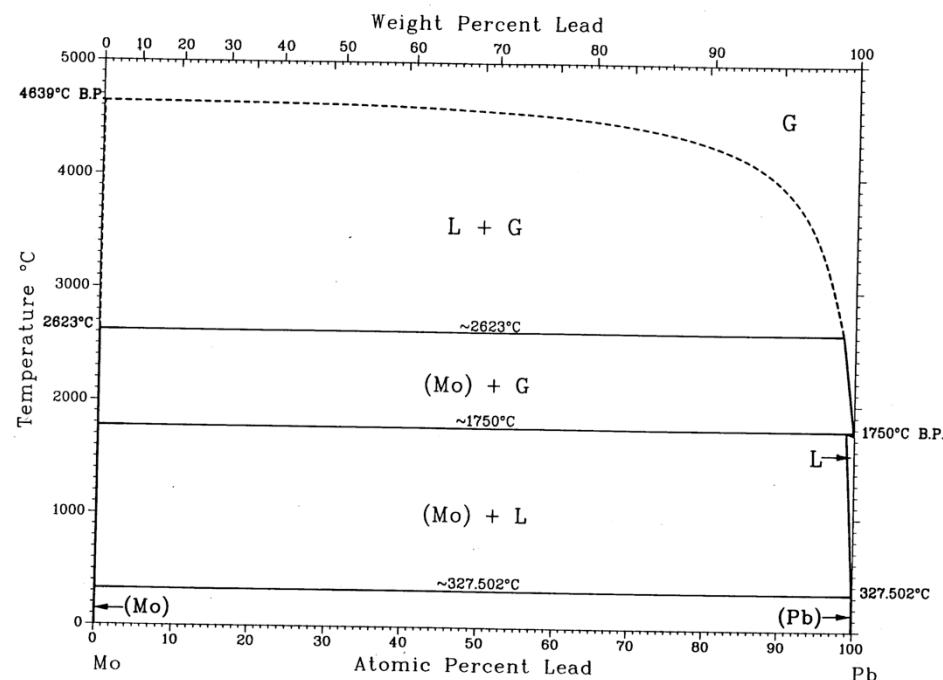
What Crucible to use for Pb?



Ti-Pb Phase Diagram



Mo-Pb Phase Diagram



Ti, Mo,
or W?



No phase diagram is available for the Pb-W system. The solubility of W in liquid Pb is less than 0.1 at.% W. No intermediate phases exist in the system.

[19Ino] claimed to have determined the solidification temperature of alloys containing up to 30 at.% W at 1300 °C; however, no further details are available in this regard. The findings of [19Ino] are not accepted here because there is no confirming evidence in any of the later experimental investiga-

Pb-W (Lead-Tungsten)

S.V. Nagender Naidu and P. Rama Rao

Pb-W Crystal Structure Data

Phase	Composition, at.% W	Pearson symbol	Space group	Strukturbericht designation	Prototype
(Pb).....	~0	cF4	Fm $\bar{3}m$	A1	Cu
(W).....	~100	cI2	I $m\bar{3}m$	A2	W

tions as to the alloy formation.

[19Ino]: S. Inouye, *Mem. Coll. Sci. Kyoto Univ.*, 4, 43-46 (1919) in German.

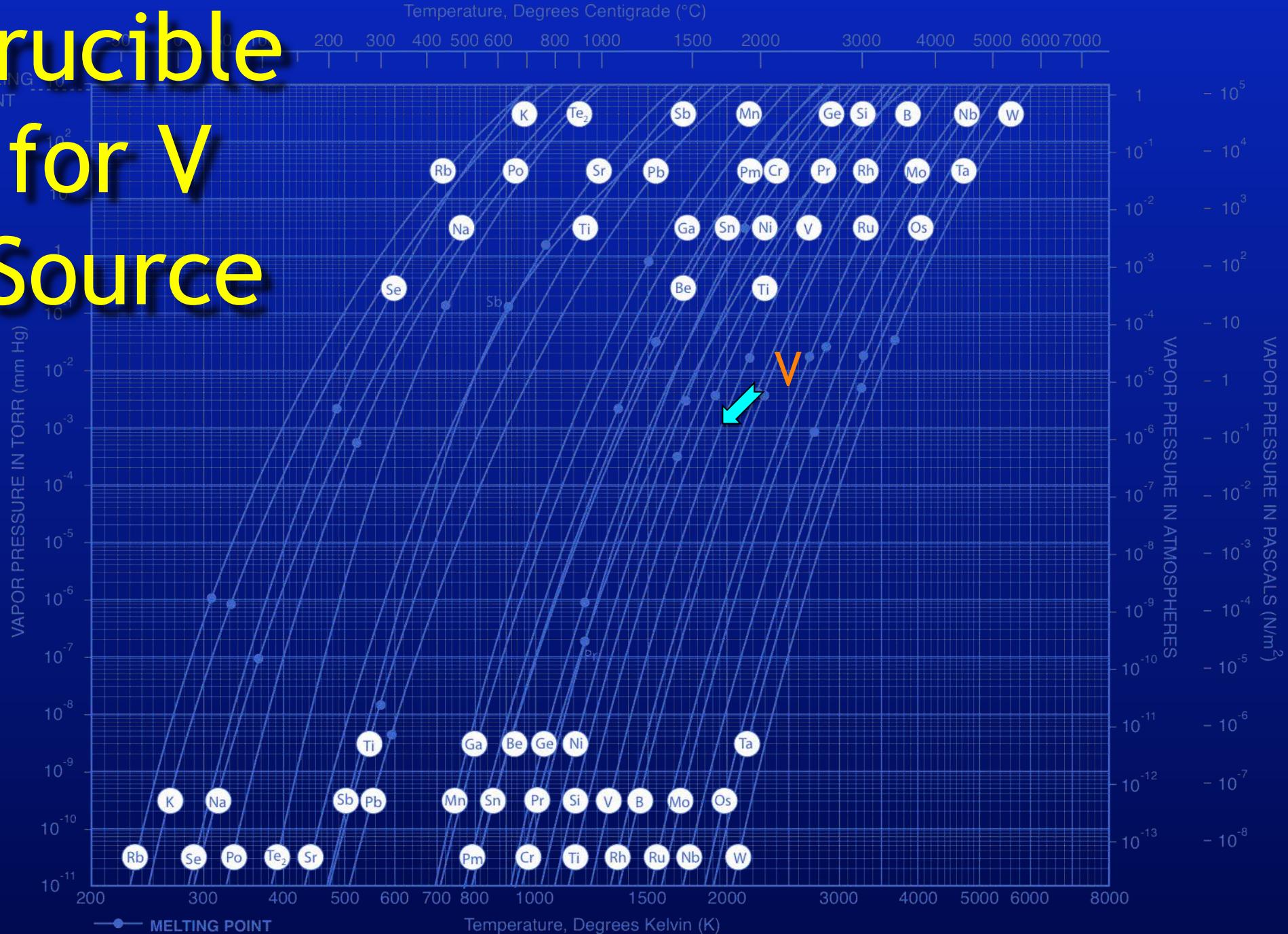
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nary Tungsten Alloys, 1991. Complete evaluation contains 1 table and 11 references.

Material	Symbol	MP (° C)	S/D	g/cm ³	Temp. (° C) for Given Vap. Press. (Torr)			Evaporation Techniques					Sputter	Comments
					10 ⁻⁸	10 ⁻⁶	10 ⁻⁴	E-Beam	Boat	Coil	Basket	Crucible		
Kanthal	FeCrAl	—	—	7.1	—	—	—	—	W	W	W	—	DC, RF	—
Lanthanum	La	921	—	6.15	990	1,212	1,388	Ex	W, Ta	—	—	Al ₂ O ₃	RF	Films will burn in air if scraped
Lanthanum Boride	LaB ₆	2,210	D	2.61	—	—	—	G	—	—	—	—	RF	—
Lanthanum Bromide	LaBr ₃	783	—	5.06	—	—	—	—	—	—	Ta	—	RF	n=1.94. Hygroscopic
Lanthanum Fluoride	LaF ₃	1,490	S	~6.0	—	—	900	G	Ta, Mo	—	Ta	—	RF	No decomposition. n ~1.6
Lanthanum Oxide	La ₂ O ₃	2,307	—	6.51	—	—	1,400	G	W, Ta	—	—	—	RF	Loses oxygen. n~1.73
Lead	Pb	328	—	11.34	342	427	497	Ex	W, Mo	W	W, Ta	Al ₂ O ₃ , Q	DC,	RF Toxic
Lead Bromide	PbBr ₂	373	—	6.66	—	—	~300	—	—	—	—	—	—	—
Lead Chloride	PbCl ₂	501	—	5.85	—	—	~325	—	Pt	—	—	Al ₂ O ₃	RF	Little decomposition
Lead Fluoride	PbF ₂	855	S	8.24	—	—	~400	—	W, Pt, Mo	—	—	BeO	RF	n = 1.75
Lead Iodide	PbI ₂	402	—	6.16	—	—	~500	—	Pt	—	—	Q	—	—
Lead Oxide	PbO	886	—	9.53	—	—	~550	—	Pt	—	—	Q, Al ₂ O ₃	RF-R	No decomposition. n ~2.6
Lead Selenide	PbSe	1,065	S	8.10	—	—	~500	—	W, Mo	—	W	Gr, Al ₂ O ₃	RF	—
Lead Stannate	PbSnO ₃	1,115	—	8.1	670	780	905	P	Pt	—	Pt	Al ₂ O ₃	RF	Disproportionates
Lead Sulfide	PbS	1,114	S	7.5	—	—	500	—	W	—	W, Mo	Q, Al ₂ O ₃	RF	Little decomposition. n = 3.92
Lead Telluride	PbTe	917	—	8.16	780	910	1,050	—	Mo, Pt, Ta	—	—	Al ₂ O ₃ , Gr	RF	Vapors toxic. Deposits are tellurium rich. Sputtering preferred or co-evaporate from two sources
Lead Titanate	PbTiO ₃	—	—	7.52	—	—	—	Ta	—	—	—	—	RF	—
Lithium	Li	181	—	0.53	227	307	407	G	Ta, SS	—	—	Al ₂ O ₃ , BeO	—	Metal reacts quickly in air
Lithium Bromide	LiBr	550	—	3.46	—	—	~500	—	Ni	—	—	—	RF	n = 1.78
Lithium Chloride	LiCl	605	—	2.07	—	—	400	—	Ni	—	—	—	RF	Preheat gently to outgas. n = 1.66
Lithium Fluoride	LiF	845	—	2.64	875	1,020	1,180	G	Ni, Ta, Mo, W	—	—	Al ₂ O ₃	RF	Rate control important for optical films. Preheat gently to outgas. n = 1.39
Lithium Iodide	LiI	449	—	4.08	—	—	400	—	Mo, W	—	—	—	RF	n = 1.96
Lithium Oxide	Li ₂ O	>1,700	—	2.01	—	—	850	—	Pt, Ir	—	—	—	RF	n = 1.64
Lutetium	Lu	1,663	—	9.84	—	—	1,300	Ex	Ta	—	—	Al ₂ O ₃	RF, DC	—
Lutetium Oxide	Lu ₂ O ₃	—	—	9.42	—	—	1,400	—	Ir	—	—	—	RF	Decomposes

Key of Symbols: * influenced by composition; ** Cr-plated rod or strip; ***all metals alumina coated; **C** = carbon; **Gr** = graphite; **Q** = quartz; **Incl** = Inconel; **VC** = vitreous carbon; **SS** = stainless steel; **Ex** = excellent; **G** = good; **F** = fair; **P** = poor; **S** = sublimes; **D** = decomposes; **RF** = RF sputtering is effective; **RF-R** = reactive RF sputter is effective; **DC** = DC sputtering is effective; **DC-R** = reactive DC sputtering is effective

Crucible for V Source



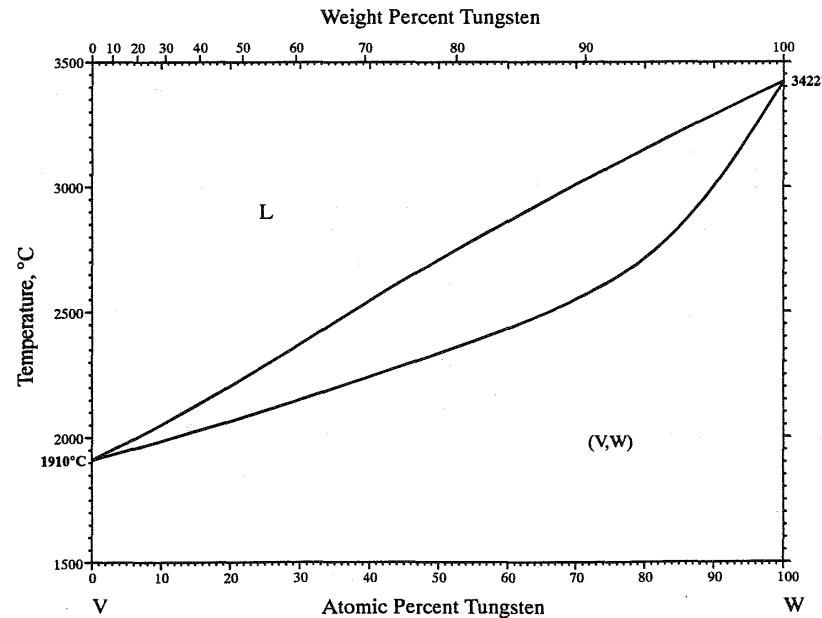
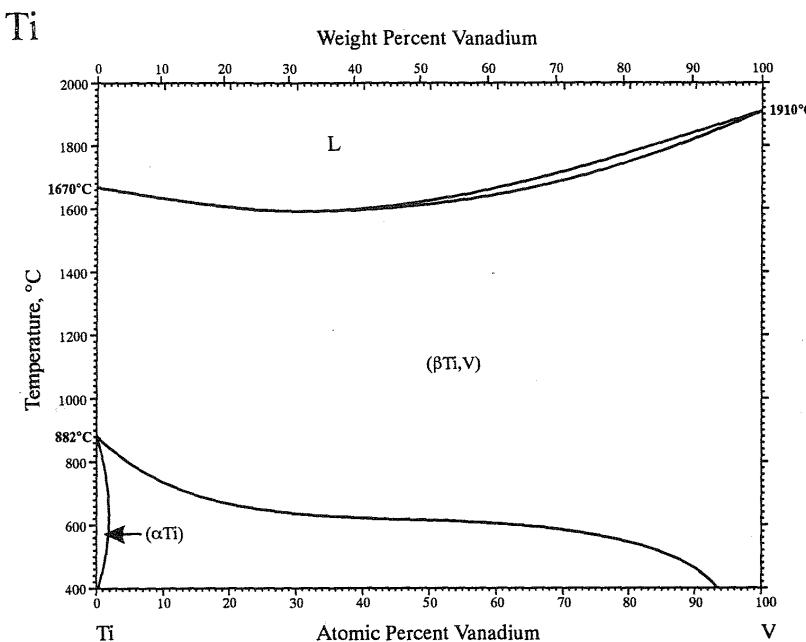
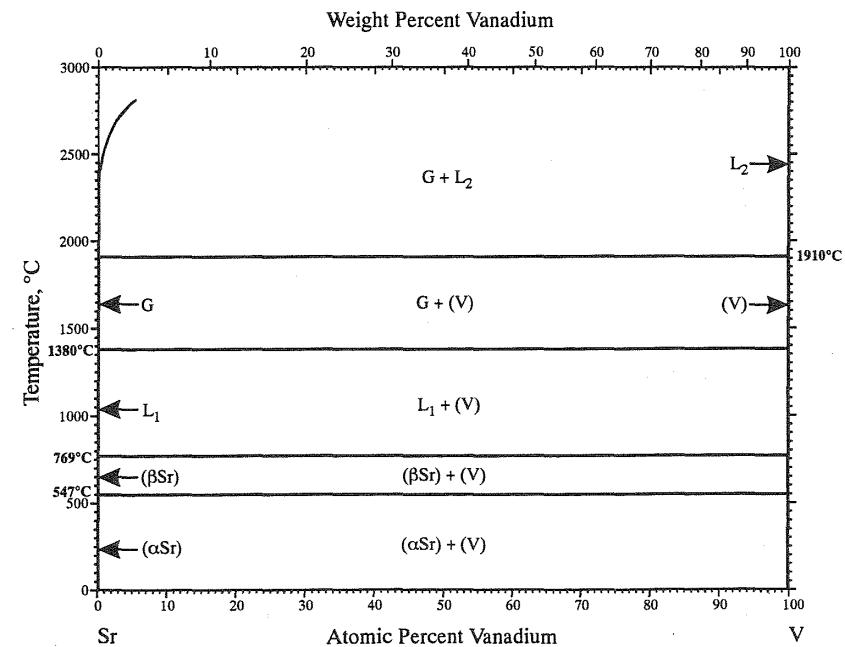
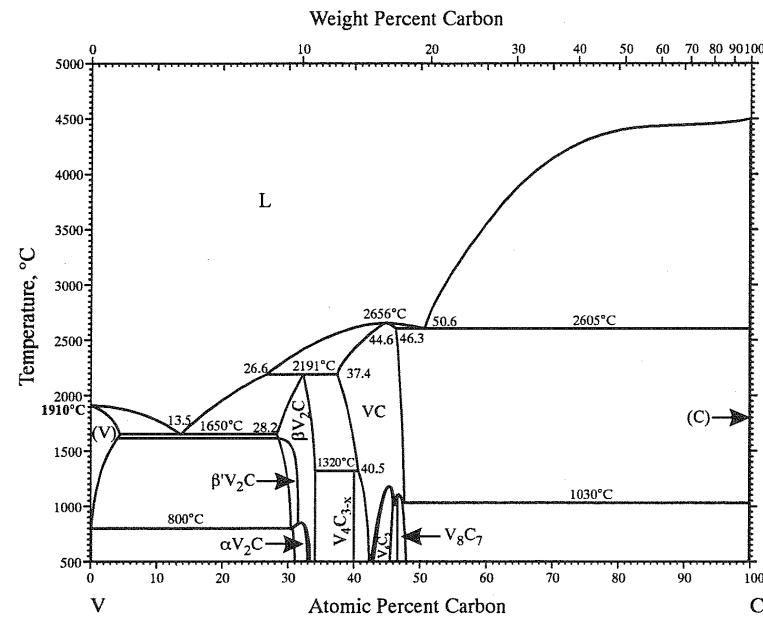
What Crucible to use for V?

Desk Handbook:

Phase Diagrams for Binary Alloys,
edited by H. Okamoto (ASM
International, 2000).

C, Sr,
Ti,
W?

PARADE



Material	Symbol	MP (° C)	S/D	g/cm ³	Temp. (° C) for Given Vap. Press. (Torr)			Evaporation Techniques					Crucible	Sputter	Comments
					10 ⁻⁸	10 ⁻⁶	10 ⁻⁴	E-Beam	Boat	Coil	Basket				
Thulium	Tm	1,545	S	9.32	461	554	680	G	Ta	—	—	Al ₂ O ₃	DC	—	
Thulium Oxide	Tm ₂ O ₃	—	—	8.90	—	—	1,500	—	Ir	—	—	—	RF	Decomposes	
Tin	Sn	232	—	7.28	682	807	997	Ex	Mo	W	W	Al ₂ O ₃	DC, RF	Wets molybdenum Use tantalum liner in E-beam guns	
Tin Oxide	SnO ₂	1,630	S	6.95	—	—	~1,000	Ex	W	W	W	Q, Al ₂ O ₃	RF, RF-R	Films from tungsten are oxygen deficient, oxidize in air. n = 2.0	
Tin Selenide	SnSe	861	—	6.18	—	—	~400	G	—	—	—	Q	RF	—	
Tin Sulfide	SnS	882	—	5.22	—	—	~450	—	—	—	—	Q	RF	—	
Tin Telluride	SnTe	780	D	6.48	—	—	~450	—	—	—	—	Q	RF	—	
Titanium	Ti	1,660	—	4.5	1,067	1,235	1,453	Ex	W	—	—	TiC	DC, RF	Alloys with refractory metals; evolves gas on first heating	
Titanium Boride	TiB ₂	2,900	—	4.50	—	—	—	P	—	—	—	—	RF, DC	—	
Titanium Carbide	TiC	3,140	—	4.93	—	—	~2,300	—	—	—	—	—	RF, DC	—	
Titanium Nitride	TiN	2,930	—	5.22	—	—	—	G	Mo	—	—	—	RF, RF-R, DC	Sputtering preferred. Decomposes with thermal evaporation	
Titanium (II) Oxide	TiO	1,750	—	4.93	—	—	~1,500	G	W, Mo	—	—	VC	RF	Preheat gently to outgas. n = 2.2	
Titanium (III) Oxide	Ti ₂ O ₃	2,130	D	4.6	—	—	—	G	W	—	—	—	RF	Decomposes	
Titanium (IV) Oxide	TiO ₂	1,830	—	4.26	—	—	~1,300	F	W, Mo	—	W	—	RF, RF-R	Suboxide, must be reoxidized to rutile. Tantalum reduces TiO ₂ to TiO and titanium. n = 2.616, 2.903	
Tungsten	W	3,410	—	19.35	2,117	2,407	2,757	G	—	—	—	—	RF, DC	Forms volatile oxides. Films hard and adherent	
Tungsten Boride	WB ₂	~2,900	—	10.77	—	—	—	P	—	—	—	—	RF	—	
Tungsten Carbide	W ₂ C	2,860	—	17.15	1,480	1,720	2,120	Ex	C	—	—	—	RF, DC	—	
Tungsten Disulfide	WS ₂	1,250	D	7.5	—	—	—	—	—	—	—	—	RF	—	
Tungsten Oxide	WO ₃	1,473	S	7.16	—	—	980	G	W, Pt	—	—	—	RF-R	Preheat gently to outgas. Tungsten reduces oxide slightly. n = 1.68	
Tungsten Selenide	WSe ₂	—	—	9.0	—	—	—	—	—	—	—	—	RF	—	
Tungsten Silicide	WSi ₂	>900	—	9.4	—	—	—	—	—	—	—	—	RF, DC	—	
Tungsten Telluride	WTe ₃	—	—	9.49	—	—	—	—	—	—	—	Q	RF	—	
Uranium	U	1,132	—	19.05	1,132	1,327	1,582	G	Mo, W	W	W	—	—	Films oxidize	
Uranium Carbide	UC ₂	2,350	—	11.28	—	—	2,100	—	—	—	—	C	RF	Decomposes	
Uranium Fluoride	UF ₄	960	—	6.70	—	—	300	—	Ni	—	—	—	RF	—	
Uranium (III) Oxide	U ₂ O ₃	1,300	D	8.30	—	—	—	—	W	—	W	—	RF-R	Disproportionates at 1,300° C to UO ₂	
Uranium (IV) Oxide	UO ₂	2,878	—	10.96	—	—	—	—	W	—	W	—	RF	Tantalum causes decomposition	
Uranium Phosphide	UP ₂	—	—	8.57	—	—	1,200	—	Ta	—	—	—	RF	Decomposes	
Uranium (II) Sulfide	US	>2,000	—	10.87	—	—	—	—	—	—	—	—	—	—	
Uranium (IV) Sulfide	US ₂	>1,100	—	7.96	—	—	—	—	W	—	—	—	RF	Slight decomposition	
Vanadium	V	1,890	—	5.96	1,162	1,332	1,547	Ex	W, Mo	—	—	—	DC, RF	Wets molybdenum. E-beam-evaporated films preferred. n = 3.03	
Vanadium Boride	VB ₂	2,400	—	5.10	—	—	—	—	—	—	—	—	RF, DC	—	
Vanadium Carbide	VC	2,810	—	5.77	—	—	~1,800	—	—	—	—	—	RF, DC	—	
Vanadium Nitride	VN	2,320	—	6.13	—	—	—	—	—	—	—	—	RF, RF-R, DC	—	
Vanadium (IV) Oxide	VO ₂	1,967	S	4.34	—	—	~575	—	—	—	—	—	RF, RF-R	Sputtering preferred.	
Vanadium (V) Oxide	V ₂ O ₅	690	D	3.36	—	—	~500	—	—	—	—	Q	RF	n = 1.46, 1.52, 1.76	
Vanadium Silicide	VSi ₂	1,700	—	4.42	—	—	—	—	—	—	—	—	RF	—	
Ytterbium	Yb	819	S	6.96	520	590	690	G	Ta	—	—	—	DC, RF	—	
Ytterbium Fluoride	YbF ₃	1,157	—	—	—	—	~800	—	Mo	—	—	—	RF	—	
Ytterbium Oxide	Yb ₂ O ₃	2,346	S	9.17	—	—	~1,500	—	Ir	—	—	—	RF, RF-R	Loses oxygen	

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Reactions with Boron Nitride (PBN)

H 1	Li 3	Be 4	Expected Reactions as calculated from free energies										He 2				
Na 11	Mg 12		B 5	C 6	N 7	O 8	F 9	Ne 10	Al 13	Si 14	P 15	S 16	Cl 17	Ar 18			
K 19	Ca 20	Sc 21	Ti 22	V 23	Cr 24	Mn 25	Fe 26	Co 27	Ni 28	Cu 29	Zn 30	Ga 31	Ge 32	As 33	Se 34	Br 35	Kr 36
Rb 37	Sr 38	Y 39	Zr 40	Nb 41	Mo 42	Tc 43	Ru 44	Rh 45	Pd 46	Ag 47	Cd 48	In 49	Sn 50	Sb 51	Te 52	I 53	Xe 54
Cs 55	Ba 56	La 57	Hf 72	Ta 73	W 74	Re 75	Os 76	Ir 77	Pt 78	Au 79	Hg 80	Ti 81	Pb 82	Bi 83	Po 84	At 85	Rn 86
Fr 87	Ra 88	Ac 89	103														

Ce 58	Pr 59	Nd 60	Pm 61	Sm 62	Eu 63	Gd 64	Tb 65	Dy 66	Ho 67	Er 68	Tm 69	Yb 70	Lu 71		
Th 90	Pa 91	U 92	Np 93	Pu 94	Am 95	Cm 96	Bk 97	Cf 98	Es 99	Fm 100	Md 101	102	103	Lw	

Reactions with Carbon (PG)

H 1	Li 3	Be 4	Expected Reactions as calculated from free energies										He 2				
Na 11	Mg 12		B 5	C 6	N 7	O 8	F 9	Ne 10	Al 13	Si 14	P 15	S 16	Cl 17	Ar 18			
K 19	Ca 20	Sc 21	Ti 22	V 23	Cr 24	Mn 25	Fe 26	Co 27	Ni 28	Cu 29	Zn 30	Ga 31	Ge 32	As 33	Se 34	Br 35	Kr 36
Rb 37	Sr 38	Y 39	Zr 40	Nb 41	Mo 42	Tc 43	Ru 44	Rh 45	Pd 46	Ag 47	Cd 48	In 49	Sn 50	Sb 51	Te 52	I 53	Xe 54
Cs 55	Ba 56	La 57	Hf 72	Ta 73	W 74	Re 75	Os 76	Ir 77	Pt 78	Au 79	Hg 80	Ti 81	Pb 82	Bi 83	Po 84	At 85	Rn 86
Fr 87	Ra 88	Ac 89	103														

Ce 58	Pr 59	Nd 60	Pm 61	Sm 62	Eu 63	Gd 64	Tb 65	Dy 66	Ho 67	Er 68	Tm 69	Yb 70	Lu 71		
Th 90	Pa 91	U 92	Np 93	Pu 94	Am 95	Cm 96	Bk 97	Cf 98	Es 99	Fm 100	Md 101	102	103	Lw	

Reactions with NbC & TaC

H 1	Li 3	Be 4	Expected Reactions as calculated from free energies										He 2				
Na 11	Mg 12		B 5	C 6	N 7	O 8	F 9	Ne 10	Al 13	Si 14	P 15	S 16	Cl 17	Ar 18			
K 19	Ca 20	Sc 21	Ti 22	V 23	Cr 24	Mn 25	Fe 26	Co 27	Ni 28	Cu 29	Zn 30	Ga 31	Ge 32	As 33	Se 34	Br 35	Kr 36
Rb 37	Sr 38	Y 39	Zr 40	Nb 41	Mo 42	Tc 43	Ru 44	Rh 45	Pd 46	Ag 47	Cd 48	In 49	Sn 50	Sb 51	Te 52	I 53	Xe 54
Cs 55	Ba 56	La 57	Hf 72	Ta 73	W 74	Re 75	Os 76	Ir 77	Pt 78	Au 79	Hg 80	Ti 81	Pb 82	Bi 83	Po 84	At 85	Rn 86
Fr 87	Ra 88	Ac 89	103														

Ce 58	Pr 59	Nd 60	Pm 61	Sm 62	Eu 63	Gd 64	Tb 65	Dy 66	Ho 67	Er 68	Tm 69	Yb 70	Lu 71		
Th 90	Pa 91	U 92	Np 93	Pu 94	Am 95	Cm 96	Bk 97	Cf 98	Es 99	Fm 100	Md 101	102	103	Lw	

Reactions with SiC

H 1	Li 3	Be 4	Expected Reactions as calculated from free energies										He 2				
Na 11	Mg 12		B 5	C 6	N 7	O 8	F 9	Ne 10	Al 13	Si 14	P 15	S 16	Cl 17	Ar 18			
K 19	Ca 20	Sc 21	Ti 22	V 23	Cr 24	Mn 25	Fe 26	Co 27	Ni 28	Cu 29	Zn 30	Ga 31	Ge 32	As 33	Se 34	Br 35	Kr 36
Rb 37	Sr 38	Y 39	Zr 40	Nb 41	Mo 42	Tc 43	Ru 44	Rh 45	Pd 46	Ag 47	Cd 48	In 49	Sn 50	Sb 51	Te 52	I 53	Xe 54
Cs 55	Ba 56	La 57	Hf 72	Ta 73	W 74	Re 75	Os 76	Ir 77	Pt 78	Au 79	Hg 80	Ti 81	Pb 82	Bi 83	Po 84	At 85	Rn 86
Fr 87	Ra 88	Ac 89	103														

Ce 58	Pr 59	Nd 60	Pm 61	Sm 62	Eu 63	Gd 64	Tb 65	Dy 66	Ho 67	Er 68	Tm 69	Yb 70	Lu 71		
Th 90	Pa 91	U 92	Np 93	Pu 94	Am 95	Cm 96	Bk 97	Cf 98	Es 99	Fm 100	Md 101	102	103	Lw	

MBE \approx Atomic Spray Painting

